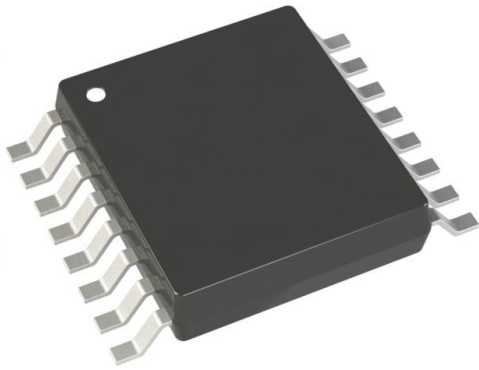


# AD5122BRUZ100 Datasheet

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DiGi Electronics Part Number	AD5122BRUZ100-DG
Manufacturer	<a href="#">Analog Devices Inc.</a>
Manufacturer Product Number	AD5122BRUZ100
Description	IC DGT POT 100KOHM 128TP 16TSSOP
Detailed Description	Digital Potentiometer 100k Ohm 2 Circuit 128 Taps SPI Interface 16-TSSOP

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## Purchase and inquiry

Manufacturer Product Number:

AD5122BRUZ100

Series:

-

DiGi-Electronics Programmable:

Not Verified

Configuration:

Potentiometer

Number of Taps:

128

Interface:

SPI

Voltage - Supply:

2.3V ~ 5.5V,  $\pm 2.25V \sim 2.75V$

Tolerance:

$\pm 8\%$

Mounting Type:

Surface Mount

Package / Case:

16-TSSOP (0.173", 4.40mm Width)

Resistance - Wiper (Ohms) (Typ):

130

Manufacturer:

Analog Devices Inc.

Product Status:

Active

Taper:

Linear

Number of Circuits:

2

Resistance (Ohms):

100k

Memory Type:

Non-Volatile

Features:

Cascade Pin

Temperature Coefficient (Typ):

35ppm/ $^{\circ}C$

Supplier Device Package:

16-TSSOP

Operating Temperature:

$-40^{\circ}C \sim 125^{\circ}C$

Base Product Number:

AD5122

## Environmental & Export classification

RoHS Status:

ROHS3 Compliant

REACH Status:

REACH Unaffected

HTSUS:

8542.39.0001

Moisture Sensitivity Level (MSL):

1 (Unlimited)

ECCN:

EAR99

## Dual-Channel, 128-/256-Position, SPI, Nonvolatile Digital Potentiometer

### FEATURES

- ▶ 10 k $\Omega$  and 100 k $\Omega$  resistance options
- ▶ Resistor tolerance:  $\pm 8\%$  maximum
- ▶ Wiper current:  $\pm 6$  mA
- ▶ Low temperature coefficient: 35 ppm/ $^{\circ}$ C
- ▶ Wide bandwidth: 3 MHz
- ▶ Fast start-up time  $< 75$   $\mu$ s
- ▶ Linear gain setting mode
- ▶ Single- and dual-supply operation
- ▶ Independent logic supply: 1.8 V to 5.5 V
- ▶ Wide operating temperature:  $-40^{\circ}$ C to  $+125^{\circ}$ C
- ▶ [3 mm  \$\times\$  3 mm package option](#)
- ▶ AEC-Q100 qualified for automotive applications

### APPLICATIONS

- ▶ Portable electronics level adjustment
- ▶ LCD panel brightness and contrast controls
- ▶ Programmable filters, delays, and time constants
- ▶ Programmable power supplies

### GENERAL DESCRIPTION

The AD5122/AD5142 potentiometers provide a nonvolatile solution for 128-/256-position adjustment applications, offering guaranteed low resistor tolerance errors of  $\pm 8\%$  and up to  $\pm 6$  mA current density in the Ax, Bx, and Wx pins.

The low resistor tolerance and low nominal temperature coefficient simplify open-loop applications as well as applications requiring tolerance matching.

The linear gain setting mode allows independent programming of the resistance between the digital potentiometer terminals through the  $R_{AW}$  and  $R_{WB}$  string resistors, allowing accurate resistor matching.

The high bandwidth and low total harmonic distortion (THD) ensure optimal performance for ac signals, making these devices suitable for filter design.

The low wiper resistance of only 40  $\Omega$  at the ends of the resistor array allows pin to pin connection.

The wiper values can be set through an SPI-compatible digital interface that also reads back the wiper register and EEPROM contents.

The AD5122/AD5142 are available in a compact, [16-lead, 3 mm  \$\times\$  3 mm LFCSP](#) and a [16-lead TSSOP](#). The devices are guaranteed to

### FUNCTIONAL BLOCK DIAGRAM

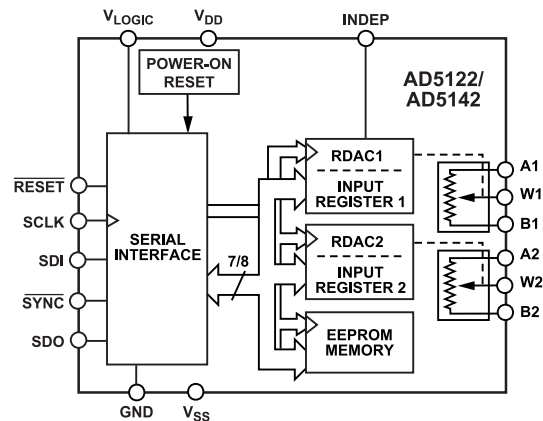


Figure 1.

operate over the extended industrial temperature range of  $-40^{\circ}$ C to  $+125^{\circ}$ C.

Table 1. Family Models

Model	Channel	Position	Interface	Package
<a href="#">AD5123<sup>1</sup></a>	Quad	128	I <sup>2</sup> C	LFCSP
<a href="#">AD5124</a>	Quad	128	SPI/I <sup>2</sup> C	LFCSP
<a href="#">AD5124</a>	Quad	128	SPI	TSSOP
<a href="#">AD5143<sup>1</sup></a>	Quad	256	I <sup>2</sup> C	LFCSP
<a href="#">AD5144</a>	Quad	256	SPI/I <sup>2</sup> C	LFCSP
<a href="#">AD5144</a>	Quad	256	SPI	TSSOP
<a href="#">AD5144A</a>	Quad	256	I <sup>2</sup> C	TSSOP
<a href="#">AD5122</a>	Dual	128	SPI	LFCSP/TSSOP
<a href="#">AD5122A</a>	Dual	128	I <sup>2</sup> C	LFCSP/TSSOP
<a href="#">AD5142</a>	Dual	256	SPI	LFCSP/TSSOP
<a href="#">AD5142A</a>	Dual	256	I <sup>2</sup> C	LFCSP/TSSOP
<a href="#">AD5121</a>	Single	128	SPI/I <sup>2</sup> C	LFCSP
<a href="#">AD5141</a>	Single	256	SPI/I <sup>2</sup> C	LFCSP

<sup>1</sup> Two potentiometers and two rheostats.

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**REVISION HISTORY****6/2024—Rev. C to Rev. D**

Changes to Thermal Resistance Section and Table 7.....	10
Changes to Ordering Guide.....	26
Added $R_{AB}$ (k $\Omega$ ), Resolution, and Interface Options.....	26

## SPECIFICATIONS

## ELECTRICAL CHARACTERISTICS—AD5122

$V_{DD} = 2.3 \text{ V to } 5.5 \text{ V}$ ,  $V_{SS} = 0 \text{ V}$ ;  $V_{DD} = 2.25 \text{ V to } 2.75 \text{ V}$ ,  $V_{SS} = -2.25 \text{ V to } -2.75 \text{ V}$ ;  $V_{LOGIC} = 1.8 \text{ V to } 5.5 \text{ V}$ ,  $-40^\circ\text{C} < T_A < +125^\circ\text{C}$ , unless otherwise noted.

Table 2.

Parameter	Symbol	Test Conditions/Comments	Min	Typ <sup>1</sup>	Max	Unit
DC CHARACTERISTICS—RHEOSTATMODE (ALL RDACs)						
Resolution	N		7			Bits
Resistor Integral Nonlinearity <sup>2</sup>	R-INL	$R_{AB} = 10 \text{ k}\Omega$ $V_{DD} \geq 2.7 \text{ V}$	-1	$\pm 0.1$	+1	LSB
		$V_{DD} < 2.7 \text{ V}$ $R_{AB} = 100 \text{ k}\Omega$	-2.5	$\pm 1$	+2.5	LSB
Resistor Differential Nonlinearity <sup>2</sup>	R-DNL	$V_{DD} \geq 2.7 \text{ V}$	-0.5	$\pm 0.1$	+0.5	LSB
		$V_{DD} < 2.7 \text{ V}$	-1	$\pm 0.25$	+1	LSB
Nominal Resistor Tolerance	$\Delta R_{AB}/R_{AB}$		-8	$\pm 1$	+8	%
Resistance Temperature Coefficient <sup>3</sup>	$(\Delta R_{AB}/R_{AB})/\Delta T \times 10^6$	Code = full scale		35		ppm/°C
Wiper Resistance <sup>3</sup>	$R_W$	Code = zero scale $R_{AB} = 10 \text{ k}\Omega$		55	125	$\Omega$
		$R_{AB} = 100 \text{ k}\Omega$		130	400	$\Omega$
Bottom Scale or Top Scale	$R_{BS}$ or $R_{TS}$	$R_{AB} = 10 \text{ k}\Omega$		40	80	$\Omega$
		$R_{AB} = 100 \text{ k}\Omega$		60	230	$\Omega$
Nominal Resistance Match	$R_{AB1}/R_{AB2}$	Code = 0xFF	-1	$\pm 0.2$	+1	%
DC CHARACTERISTICS—POTENTIOMETERDIVIDER MODE (ALL RDACs)						
Integral Nonlinearity <sup>4</sup>	INL	$R_{AB} = 10 \text{ k}\Omega$	-0.5	$\pm 0.1$	+0.5	LSB
		$R_{AB} = 100 \text{ k}\Omega$	-0.25	$\pm 0.1$	+0.25	LSB
Differential Nonlinearity <sup>4</sup>	DNL		-0.25	$\pm 0.1$	+0.25	LSB
Full-Scale Error	$V_{WFSE}$	$R_{AB} = 10 \text{ k}\Omega$	-1.5	-0.1		LSB
		$R_{AB} = 100 \text{ k}\Omega$	-0.5	$\pm 0.1$	+0.5	LSB
Zero-Scale Error	$V_{WZSE}$	$R_{AB} = 10 \text{ k}\Omega$		1	1.5	LSB
		$R_{AB} = 100 \text{ k}\Omega$		0.25	0.5	LSB
Voltage Divider Temperature Coefficient <sup>3</sup>	$(\Delta V_W/V_W)/\Delta T \times 10^6$	Code = half scale		$\pm 5$		ppm/°C
RESISTOR TERMINALS						
Maximum Continuous Current	$I_A$ , $I_B$ , and $I_W$	$R_{AB} = 10 \text{ k}\Omega$	-6		+6	mA
		$R_{AB} = 100 \text{ k}\Omega$	-1.5		+1.5	mA
Terminal Voltage Range <sup>5</sup>			$V_{SS}$		$V_{DD}$	V
Capacitance A, Capacitance B <sup>3</sup>	$C_A$ , $C_B$	f = 1 MHz, measured to GND, code = half scale $R_{AB} = 10 \text{ k}\Omega$		25		pF
		$R_{AB} = 100 \text{ k}\Omega$		12		pF
Capacitance W <sup>3</sup>	$C_W$	f = 1 MHz, measured to GND, code = half scale $R_{AB} = 10 \text{ k}\Omega$		12		pF

## SPECIFICATIONS

Table 2. (Continued)

Parameter	Symbol	Test Conditions/Comments	Min	Typ <sup>1</sup>	Max	Unit
Common-Mode Leakage Current <sup>3</sup>		$R_{AB} = 100\text{ k}\Omega$ $V_A = V_W = V_B$	-500	5 $\pm 15$	+500	pF nA
DIGITAL INPUTS						
Input Logic <sup>3</sup>						
High	$V_{INH}$	$V_{LOGIC} = 1.8\text{ V to }2.3\text{ V}$ $V_{LOGIC} = 2.3\text{ V to }5.5\text{ V}$	$0.8 \times V_{LOGIC}$ $0.7 \times V_{LOGIC}$			V V
Low	$V_{INL}$				$0.2 \times V_{LOGIC}$	V
Input Hysteresis <sup>3</sup>	$V_{HYST}$		$0.1 \times V_{LOGIC}$			V
Input Current <sup>3</sup>	$I_{IN}$				$\pm 1$	$\mu\text{A}$
Input Capacitance <sup>3</sup>	$C_{IN}$			5		pF
DIGITAL OUTPUTS						
Output High Voltage <sup>3</sup>	$V_{OH}$	$R_{PULL-UP} = 2.2\text{ k}\Omega\text{ to }V_{LOGIC}$		$V_{LOGIC}$		V
Output Low Voltage <sup>3</sup>	$V_{OL}$	$I_{SINK} = 3\text{ mA}$ $I_{SINK} = 6\text{ mA}, V_{LOGIC} > 2.3\text{ V}$			0.4 0.6	V V
Three-State Leakage Current			-1		+1	$\mu\text{A}$
Three-State Output Capacitance				2		pF
POWER SUPPLIES						
Single-Supply Power Range		$V_{SS} = \text{GND}$	2.3		5.5	V
Dual-Supply Power Range			$\pm 2.25$		$\pm 2.75$	V
Logic Supply Range		Single supply, $V_{SS} = \text{GND}$ Dual supply, $V_{SS} < \text{GND}$	1.8 2.25		$V_{DD}$ $V_{DD}$	V V
Positive Supply Current	$I_{DD}$	$V_{IH} = V_{LOGIC}\text{ or }V_{IL} = \text{GND}$ $V_{DD} = 5.5\text{ V}$ $V_{DD} = 2.3\text{ V}$		0.7 400	5.5	$\mu\text{A}$ nA
Negative Supply Current	$I_{SS}$	$V_{IH} = V_{LOGIC}\text{ or }V_{IL} = \text{GND}$	-5.5	-0.7		$\mu\text{A}$
EEPROM Store Current <sup>3,6</sup>	$I_{DD\_EEPROM\_STORE}$	$V_{IH} = V_{LOGIC}\text{ or }V_{IL} = \text{GND}$		2		mA
EEPROM Read Current <sup>3,7</sup>	$I_{DD\_EEPROM\_READ}$	$V_{IH} = V_{LOGIC}\text{ or }V_{IL} = \text{GND}$		320		$\mu\text{A}$
Logic Supply Current	$I_{LOGIC}$	$V_{IH} = V_{LOGIC}\text{ or }V_{IL} = \text{GND}$		0.05	1.4	$\mu\text{A}$
Power Dissipation <sup>8</sup>	$P_{DISS}$	$V_{IH} = V_{LOGIC}\text{ or }V_{IL} = \text{GND}$		3.5		$\mu\text{W}$
Power Supply Rejection Ratio	PSRR	$\Delta V_{DD}/\Delta V_{SS} = V_{DD} \pm 10\%$ , code = full scale		-66	-60	dB
DYNAMIC CHARACTERISTICS <sup>9</sup>						
Bandwidth	BW	-3 dB $R_{AB} = 10\text{ k}\Omega$ $R_{AB} = 100\text{ k}\Omega$		3 0.43		MHz MHz
Total Harmonic Distortion	THD	$V_{DD}/V_{SS} = \pm 2.5\text{ V}, V_A = 1\text{ V rms}, V_B = 0\text{ V}, f = 1\text{ kHz}$ $R_{AB} = 10\text{ k}\Omega$ $R_{AB} = 100\text{ k}\Omega$		-80 -90		dB dB
Resistor Noise Density	$e_{N\_WB}$	Code = half scale, $T_A = 25^\circ\text{C}, f = 10\text{ kHz}$ $R_{AB} = 10\text{ k}\Omega$ $R_{AB} = 100\text{ k}\Omega$		7 20		nV/ $\sqrt{\text{Hz}}$ nV/ $\sqrt{\text{Hz}}$
$V_W$ Settling Time	$t_S$	$V_A = 5\text{ V}, V_B = 0\text{ V}$ , from zero scale to full scale, $\pm 0.5\text{ LSB}$ error band $R_{AB} = 10\text{ k}\Omega$ $R_{AB} = 100\text{ k}\Omega$		2 12		$\mu\text{s}$ $\mu\text{s}$
Crosstalk ( $C_{W1}/C_{W2}$ )	$C_T$	$R_{AB} = 10\text{ k}\Omega$ $R_{AB} = 100\text{ k}\Omega$		10 25		nV-sec nV-sec

## SPECIFICATIONS

Table 2. (Continued)

Parameter	Symbol	Test Conditions/Comments	Min	Typ <sup>1</sup>	Max	Unit
Analog Crosstalk Endurance <sup>10</sup>	$C_{TA}$	$T_A = 25^\circ\text{C}$		-90 1		dB Mcycles
Data Retention <sup>11, 12</sup>			100	50		kcycles Years

<sup>1</sup> Typical values represent average readings at  $25^\circ\text{C}$ ,  $V_{DD} = 5\text{ V}$ ,  $V_{SS} = 0\text{ V}$ , and  $V_{LOGIC} = 5\text{ V}$ .

<sup>2</sup> Resistor integral nonlinearity (R-INL) error is the deviation from an ideal value measured between the maximum resistance and the minimum resistance wiper positions. R-DNL measures the relative step change from ideal between successive tap positions. The maximum wiper current is limited to  $(0.7 \times V_{DD})/R_{AB}$ .

<sup>3</sup> Guaranteed by design and characterization, not subject to production test.

<sup>4</sup> INL and DNL are measured at  $V_{WB}$  with the RDAC configured as a potentiometer divider similar to a voltage output DAC.  $V_A = V_{DD}$  and  $V_B = 0\text{ V}$ . DNL specification limits of  $\pm 1\text{ LSB}$  maximum are guaranteed monotonic operating conditions.

<sup>5</sup> Resistor Terminal A, Resistor Terminal B, and Resistor Terminal W have no limitations on polarity with respect to each other. Dual-supply operation enables ground referenced bipolar signal adjustment.

<sup>6</sup> Different from operating current; supply current for EEPROM program lasts approximately 30 ms.

<sup>7</sup> Different from operating current; supply current for EEPROM read lasts approximately 20  $\mu\text{s}$ .

<sup>8</sup>  $P_{DISS}$  is calculated from  $(I_{DD} \times V_{DD}) + (I_{LOGIC} \times V_{LOGIC})$ .

<sup>9</sup> All dynamic characteristics use  $V_{DD}/V_{SS} = \pm 2.5\text{ V}$ , and  $V_{LOGIC} = 2.5\text{ V}$ .

<sup>10</sup> Endurance is qualified to 100,000 cycles per JEDEC Standard 22, Method A117 and measured at  $-40^\circ\text{C}$  to  $+125^\circ\text{C}$ .

<sup>11</sup> Retention lifetime equivalent at junction temperature ( $T_J$ ) =  $125^\circ\text{C}$  per JEDEC Standard 22, Method A117. Retention lifetime, based on an activation energy of 1 eV, derates with junction temperature in the Flash/EE memory.

<sup>12</sup> 50 years applies to an endurance of 1k cycles. An endurance of 100k cycles has an equivalent retention lifetime of 5 years.

## ELECTRICAL CHARACTERISTICS—AD5142

$V_{DD} = 2.3\text{ V}$  to  $5.5\text{ V}$ ,  $V_{SS} = 0\text{ V}$ ;  $V_{DD} = 2.25\text{ V}$  to  $2.75\text{ V}$ ,  $V_{SS} = -2.25\text{ V}$  to  $-2.75\text{ V}$ ;  $V_{LOGIC} = 1.8\text{ V}$  to  $5.5\text{ V}$ ,  $-40^\circ\text{C} < T_A < +125^\circ\text{C}$ , unless otherwise noted.

Table 3.

Parameter	Symbol	Test Conditions/Comments	Min	Typ <sup>1</sup>	Max	Unit
DC CHARACTERISTICS—RHEOSTATMODE (ALL RDACs)						
Resolution	N		8			Bits
Resistor Integral Nonlinearity <sup>2</sup>	R-INL	$R_{AB} = 10\text{ k}\Omega$				
		$V_{DD} \geq 2.7\text{ V}$	-2	$\pm 0.2$	+2	LSB
		$V_{DD} < 2.7\text{ V}$	-5	$\pm 1.5$	+5	LSB
		$R_{AB} = 100\text{ k}\Omega$				
Resistor Differential Nonlinearity <sup>2</sup>	R-DNL	$V_{DD} \geq 2.7\text{ V}$	-1	$\pm 0.1$	+1	LSB
		$V_{DD} < 2.7\text{ V}$	-2	$\pm 0.5$	+2	LSB
Resistor Differential Nonlinearity <sup>2</sup>	R-DNL		-0.5	$\pm 0.2$	+0.5	LSB
Nominal Resistor Tolerance	$\Delta R_{AB}/R_{AB}$		-8	$\pm 1$	+8	%
Resistance Temperature Coefficient <sup>3</sup>	$(\Delta R_{AB}/R_{AB})/\Delta T \times 10^6$	Code = full scale		35		ppm/ $^\circ\text{C}$
Wiper Resistance <sup>3</sup>	$R_W$	Code = zero scale				
		$R_{AB} = 10\text{ k}\Omega$		55	125	$\Omega$
		$R_{AB} = 100\text{ k}\Omega$		130	400	$\Omega$
Bottom Scale or Top Scale	$R_{BS}$ or $R_{TS}$	$R_{AB} = 10\text{ k}\Omega$		40	80	$\Omega$
		$R_{AB} = 100\text{ k}\Omega$		60	230	$\Omega$
Nominal Resistance Match	$R_{AB1}/R_{AB2}$	Code = 0xFF	-1	$\pm 0.2$	+1	%

## SPECIFICATIONS

Table 3. (Continued)

Parameter	Symbol	Test Conditions/Comments	Min	Typ <sup>1</sup>	Max	Unit
DC CHARACTERISTICS— POTENTIOMETER/DIVIDER MODE (ALL RDACs)						
Integral Nonlinearity <sup>4</sup>	INL	$R_{AB} = 10\text{ k}\Omega$ $R_{AB} = 100\text{ k}\Omega$	-1 -0.5	$\pm 0.2$ $\pm 0.1$	+1 +0.5	LSB LSB
Differential Nonlinearity <sup>4</sup>	DNL		-0.5	$\pm 0.2$	+0.5	LSB
Full-Scale Error	$V_{WFSE}$	$R_{AB} = 10\text{ k}\Omega$ $R_{AB} = 100\text{ k}\Omega$	-2.5 -1	-0.1 $\pm 0.2$		LSB LSB
Zero-Scale Error	$V_{WZSE}$	$R_{AB} = 10\text{ k}\Omega$ $R_{AB} = 100\text{ k}\Omega$		1.2 0.5	3 1	LSB LSB
Voltage Divider Temperature Coefficient <sup>3</sup>	$(\Delta V_W/V_W)/\Delta T \times 10^6$	Code = half scale		$\pm 5$		ppm/°C
RESISTOR TERMINALS						
Maximum Continuous Current	$I_A$ , $I_B$ , and $I_W$	$R_{AB} = 10\text{ k}\Omega$ $R_{AB} = 100\text{ k}\Omega$	-6 -1.5		+6 +1.5	mA mA
Terminal Voltage Range <sup>5</sup>			$V_{SS}$		$V_{DD}$	V
Capacitance A, Capacitance B <sup>3</sup>	$C_A$ , $C_B$	$f = 1\text{ MHz}$ , measured to GND, code = half scale $R_{AB} = 10\text{ k}\Omega$ $R_{AB} = 100\text{ k}\Omega$		25 12		pF pF
Capacitance W <sup>3</sup>	$C_W$	$f = 1\text{ MHz}$ , measured to GND, code = half scale $R_{AB} = 10\text{ k}\Omega$ $R_{AB} = 100\text{ k}\Omega$		12 5		pF pF
Common-Mode Leakage Current <sup>3</sup>		$V_A = V_W = V_B$	-500	$\pm 15$	+500	nA
DIGITAL INPUTS						
Input Logic <sup>3</sup>						
High	$V_{INH}$	$V_{LOGIC} = 1.8\text{ V to } 2.3\text{ V}$ $V_{LOGIC} = 2.3\text{ V to } 5.5\text{ V}$	$0.8 \times V_{LOGIC}$ $0.7 \times V_{LOGIC}$			V V
Low	$V_{INL}$				$0.2 \times V_{LOGIC}$	V
Input Hysteresis <sup>3</sup>	$V_{HYST}$		$0.1 \times V_{LOGIC}$			V
Input Current <sup>3</sup>	$I_{IN}$				$\pm 1$	$\mu\text{A}$
Input Capacitance <sup>3</sup>	$C_{IN}$			5		pF
DIGITAL OUTPUTS						
Output High Voltage <sup>3</sup>	$V_{OH}$	$R_{PULL-UP} = 2.2\text{ k}\Omega$ to $V_{LOGIC}$		$V_{LOGIC}$		V
Output Low Voltage <sup>3</sup>	$V_{OL}$	$I_{SINK} = 3\text{ mA}$ $I_{SINK} = 6\text{ mA}$ , $V_{LOGIC} > 2.3\text{ V}$			0.4 0.6	V V
Three-State Leakage Current			-1		+1	$\mu\text{A}$
Three-State Output Capacitance				2		pF
POWER SUPPLIES						
Single-Supply Power Range		$V_{SS} = \text{GND}$	2.3		5.5	V
Dual-Supply Power Range			$\pm 2.25$		$\pm 2.75$	V
Logic Supply Range		Single supply, $V_{SS} = \text{GND}$ Dual supply, $V_{SS} < \text{GND}$	1.8 2.25		$V_{DD}$ $V_{DD}$	V V
Positive Supply Current	$I_{DD}$	$V_{IH} = V_{LOGIC}$ or $V_{IL} = \text{GND}$ $V_{DD} = 5.5\text{ V}$ $V_{DD} = 2.3\text{ V}$		0.7 400	5.5	$\mu\text{A}$ nA

## SPECIFICATIONS

Table 3. (Continued)

Parameter	Symbol	Test Conditions/Comments	Min	Typ <sup>1</sup>	Max	Unit
Negative Supply Current	I <sub>SS</sub>	V <sub>IH</sub> = V <sub>LOGIC</sub> or V <sub>IL</sub> = GND	-5.5	-0.7		μA
EEPROM Store Current <sup>3, 6</sup>	I <sub>DD_EEPROM_STORE</sub>	V <sub>IH</sub> = V <sub>LOGIC</sub> or V <sub>IL</sub> = GND		2		mA
EEPROM Read Current <sup>3, 7</sup>	I <sub>DD_EEPROM_READ</sub>	V <sub>IH</sub> = V <sub>LOGIC</sub> or V <sub>IL</sub> = GND		320		μA
Logic Supply Current	I <sub>LOGIC</sub>	V <sub>IH</sub> = V <sub>LOGIC</sub> or V <sub>IL</sub> = GND		0.05	1.4	μA
Power Dissipation <sup>8</sup>	P <sub>DISS</sub>	V <sub>IH</sub> = V <sub>LOGIC</sub> or V <sub>IL</sub> = GND		3.5		μW
Power Supply Rejection Ratio	PSRR	ΔV <sub>DD</sub> /ΔV <sub>SS</sub> = V <sub>DD</sub> ± 10%, code = full scale		-66	-60	dB
<b>DYNAMIC CHARACTERISTICS<sup>9</sup></b>						
Bandwidth	BW	-3 dB		3		MHz
		R <sub>AB</sub> = 10 kΩ		0.43		MHz
Total Harmonic Distortion	THD	V <sub>DD</sub> /V <sub>SS</sub> = ±2.5 V, V <sub>A</sub> = 1 V rms, V <sub>B</sub> = 0 V, f = 1 kHz				
		R <sub>AB</sub> = 10 kΩ		-80		dB
		R <sub>AB</sub> = 100 kΩ		-90		dB
Resistor Noise Density	e <sub>N_WB</sub>	Code = half scale, T <sub>A</sub> = 25°C, f = 10 kHz				
		R <sub>AB</sub> = 10 kΩ		7		nV/√Hz
		R <sub>AB</sub> = 100 kΩ		20		nV/√Hz
V <sub>W</sub> Settling Time	t <sub>s</sub>	V <sub>A</sub> = 5 V, V <sub>B</sub> = 0 V, from zero scale to full scale, ±0.5 LSB error band				
		R <sub>AB</sub> = 10 kΩ		2		μs
		R <sub>AB</sub> = 100 kΩ		12		μs
Crosstalk (C <sub>W1</sub> /C <sub>W2</sub> )	C <sub>T</sub>	R <sub>AB</sub> = 10 kΩ		10		nV-sec
		R <sub>AB</sub> = 100 kΩ		25		nV-sec
Analog Crosstalk	C <sub>TA</sub>			-90		dB
Endurance <sup>10</sup>		T <sub>A</sub> = 25°C		1		Mcycles
Data Retention <sup>11, 12</sup>			100	50		kcycles Years

<sup>1</sup> Typical values represent average readings at 25°C, V<sub>DD</sub> = 5 V, V<sub>SS</sub> = 0 V, and V<sub>LOGIC</sub> = 5 V.

<sup>2</sup> Resistor integral nonlinearity (R-INL) error is the deviation from an ideal value measured between the maximum resistance and the minimum resistance wiper positions. R-DNL measures the relative step change from ideal between successive tap positions. The maximum wiper current is limited to (0.7 × V<sub>DD</sub>)/R<sub>AB</sub>.

<sup>3</sup> Guaranteed by design and characterization, not subject to production test.

<sup>4</sup> INL and DNL are measured at V<sub>WB</sub> with the RDAC configured as a potentiometer divider similar to a voltage output DAC. V<sub>A</sub> = V<sub>DD</sub> and V<sub>B</sub> = 0 V. DNL specification limits of ±1 LSB maximum are guaranteed monotonic operating conditions.

<sup>5</sup> Resistor Terminal A, Resistor Terminal B, and Resistor Terminal W have no limitations on polarity with respect to each other. Dual-supply operation enables ground referenced bipolar signal adjustment.

<sup>6</sup> Different from operating current; supply current for EEPROM program lasts approximately 30 ms.

<sup>7</sup> Different from operating current; supply current for EEPROM read lasts approximately 20 μs.

<sup>8</sup> P<sub>DISS</sub> is calculated from (I<sub>DD</sub> × V<sub>DD</sub>) + (I<sub>LOGIC</sub> × V<sub>LOGIC</sub>).

<sup>9</sup> All dynamic characteristics use V<sub>DD</sub>/V<sub>SS</sub> = ±2.5 V, and V<sub>LOGIC</sub> = 2.5 V.

<sup>10</sup> Endurance is qualified to 100,000 cycles per JEDEC Standard 22, Method A117 and measured at -40°C to +125°C.

<sup>11</sup> Retention lifetime equivalent at junction temperature (T<sub>J</sub>) = 125°C per JEDEC Standard 22, Method A117. Retention lifetime, based on an activation energy of 1 eV, derates with junction temperature in the Flash/EE memory.

<sup>12</sup> 50 years applies to an endurance of 1k cycles. An endurance of 100k cycles has an equivalent retention lifetime of 5 years.

## SPECIFICATIONS

## INTERFACE TIMING SPECIFICATIONS

$V_{\text{LOGIC}} = 1.8 \text{ V}$  to  $5.5 \text{ V}$ ; all specifications  $T_{\text{MIN}}$  to  $T_{\text{MAX}}$ , unless otherwise noted.

Table 4. SPI Interface<sup>1</sup>

Parameter <sup>2</sup>	Test Conditions/Comments	Min	Typ	Max	Unit	Description
$t_1$	$V_{\text{LOGIC}} > 1.8 \text{ V}$	20			ns	SCLK cycle time
	$V_{\text{LOGIC}} = 1.8 \text{ V}$	30			ns	
$t_2$	$V_{\text{LOGIC}} > 1.8 \text{ V}$	10			ns	SCLK high time
	$V_{\text{LOGIC}} = 1.8 \text{ V}$	15			ns	
$t_3$	$V_{\text{LOGIC}} > 1.8 \text{ V}$	10			ns	SCLK low time
	$V_{\text{LOGIC}} = 1.8 \text{ V}$	15			ns	
$t_4$		10			ns	$\overline{\text{SYNC}}$ to SCLK falling edge setup time
$t_5$		5			ns	Data setup time
$t_6$		5			ns	Data hold time
$t_7$		10			ns	$\overline{\text{SYNC}}$ rising edge to next SCLK fall ignored
$t_8$ <sup>3</sup>		20			ns	Minimum $\overline{\text{SYNC}}$ high time
$t_9$ <sup>4</sup>			50		ns	SCLK rising edge to SDO valid
$t_{10}$				500	ns	$\overline{\text{SYNC}}$ rising edge to SDO pin disable

<sup>1</sup> Refer to the [AN-1248](#) for additional information about the serial peripheral interface.

<sup>2</sup> All input signals are specified with  $t_r = t_f = 1 \text{ ns/V}$  (10% to 90% of  $V_{\text{DD}}$ ) and timed from a voltage level of  $(V_{\text{L}} + V_{\text{H}})/2$ .

<sup>3</sup> Refer to  $t_{\text{EEPROM\_PROGRAM}}$  and  $t_{\text{EEPROM\_READBACK}}$  for memory commands operations (see [Table 5](#)).

<sup>4</sup>  $R_{\text{PULL\_UP}} = 2.2 \text{ k}\Omega$  to  $V_{\text{DD}}$  with a capacitance load of  $168 \text{ pF}$ .

Table 5. Control Pins

Parameter	Min	Typ	Max	Unit	Description
$t_1$	0.1		10	$\mu\text{s}$	RESET low time
$t_{\text{EEPROM\_PROGRAM}}$ <sup>1</sup>		15	50	ms	Memory program time (not shown in <a href="#">Figure 5</a> )
$t_{\text{EEPROM\_READBACK}}$		7	30	$\mu\text{s}$	Memory readback time (not shown in <a href="#">Figure 5</a> )
$t_{\text{POWER\_UP}}$ <sup>2</sup>			75	$\mu\text{s}$	Start-up time (not shown in <a href="#">Figure 5</a> )
$t_{\text{RESET}}$		30		$\mu\text{s}$	Reset EEPROM restore time (not shown in <a href="#">Figure 5</a> )

<sup>1</sup> EEPROM program time depends on the temperature and EEPROM write cycles. Higher timing is expected at lower temperatures and higher write cycles.

<sup>2</sup> Maximum time after  $V_{\text{DD}} - V_{\text{SS}}$  is equal to  $2.3 \text{ V}$ .

## SHIFT REGISTER AND TIMING DIAGRAMS

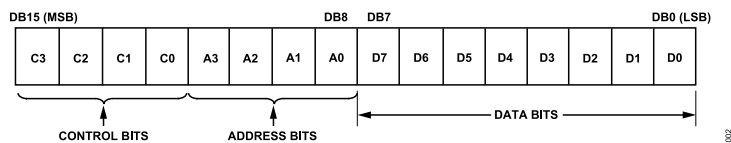


Figure 2. Input Shift Register Contents

SPECIFICATIONS

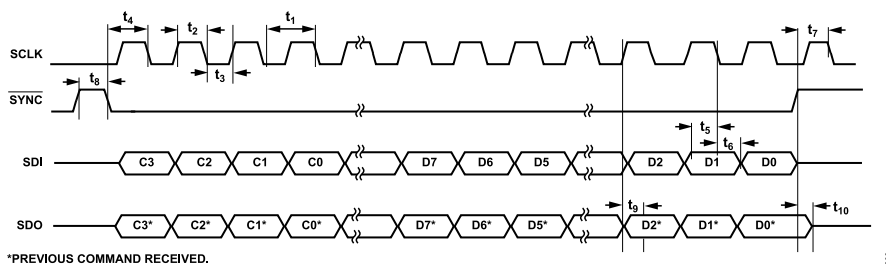


Figure 3. SPI Serial Interface Timing Diagram, Clock Polarity (CPOL) = 0, Clock Phase (CPHA) = 1

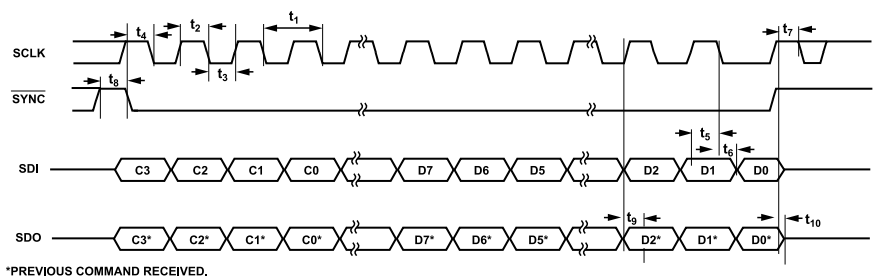


Figure 4. SPI Serial Interface Timing Diagram, Clock Polarity (CPOL) = 1, Clock Phase (CPHA) = 0

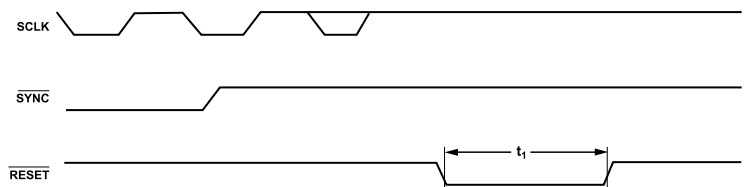


Figure 5. Control Pins Timing Diagram

## ABSOLUTE MAXIMUM RATINGS

$T_A = 25^\circ\text{C}$ , unless otherwise noted.

Table 6.

Parameter	Rating
$V_{DD}$ to GND	-0.3 V to +7.0 V
$V_{SS}$ to GND	+0.3 V to -7.0 V
$V_{DD}$ to $V_{SS}$	7 V
$V_{LOGIC}$ to GND	-0.3 V to $V_{DD} + 0.3$ V or +7.0 V (whichever is less)
$V_A, V_W, V_B$ to GND	$V_{SS} - 0.3$ V, $V_{DD} + 0.3$ V or +7.0 V (whichever is less)
$I_A, I_W, I_B$ Pulsed <sup>1</sup>	
Frequency > 10 kHz	
$R_{AW} = 10$ k $\Omega$	$\pm 6$ mA/d <sup>2</sup>
$R_{AW} = 100$ k $\Omega$	$\pm 1.5$ mA/d <sup>2</sup>
Frequency $\leq$ 10 kHz	
$R_{AW} = 10$ k $\Omega$	$\pm 6$ mA/ $\sqrt{d^2}$
$R_{AW} = 100$ k $\Omega$	$\pm 1.5$ mA/ $\sqrt{d^2}$
Digital Inputs	-0.3 V to $V_{LOGIC} + 0.3$ V or +7 V (whichever is less)
Operating Temperature Range, $T_A$ <sup>3</sup>	-40°C to +125°C
Maximum Junction Temperature, $T_J$ Maximum	150°C
Storage Temperature Range	-65°C to +150°C
Reflow Soldering	
Peak Temperature	260°C
Time at Peak Temperature	20 sec to 40 sec
Package Power Dissipation	$(T_J \text{ max} - T_A)/\theta_{JA}$
FICDM	1.5 kV

<sup>1</sup> Maximum terminal current is bounded by the maximum current handling of the switches, maximum power dissipation of the package, and maximum applied voltage across any two of the A, B, and W terminals at a given resistance.

<sup>2</sup> d = pulse duty factor.

<sup>3</sup> Includes programming of EEPROM memory.

Stresses at or above those listed under Absolute Maximum Ratings may cause permanent damage to the product. This is a stress rating only; functional operation of the product at these or any other conditions above those indicated in the operational section of this specification is not implied. Operation beyond the maximum operating conditions for extended periods may affect product reliability.

## THERMAL RESISTANCE

Thermal performance is directly linked to printed circuit board (PCB) design and operating environment. Careful attention to PCB thermal design is required.

$\theta_{JA}$  is the junction to ambient thermal resistance, measured in a JEDEC natural convection environment.

$\theta_{JB}$  is the junction to board thermal resistance, measured at a point on the board 1mm from the package edge, along the package centerline, measured in a JEDEC  $\theta_{JB}$  environment.

Table 7. Thermal Resistance

Package Type <sup>1</sup>	$\theta_{JA}$	$\theta_{JB}$	Unit
16-Lead LFCSP	75.4	33.4	°C/W
16-Lead TSSOP	134.43	No Data	°C/W

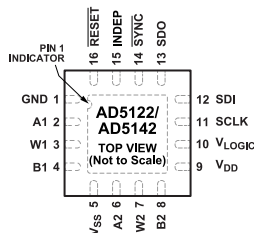
<sup>1</sup> Thermal impedance simulated values are based on a JEDEC 2S2P thermal test board. See JEDEC JESD-51.

## ESD CAUTION



**ESD (electrostatic discharge) sensitive device.** Charged devices and circuit boards can discharge without detection. Although this product features patented or proprietary protection circuitry, damage may occur on devices subjected to high energy ESD. Therefore, proper ESD precautions should be taken to avoid performance degradation or loss of functionality.

## PIN CONFIGURATIONS AND FUNCTION DESCRIPTIONS



NOTES  
 1. EXPOSED PAD. CONNECT THE EXPOSED PAD TO THE POTENTIAL OF THE  $V_{SS}$  PIN, OR, ALTERNATIVELY, LEAVE IT ELECTRICALLY UNCONNECTED. IT IS RECOMMENDED THAT THE PAD BE THERMALLY CONNECTED TO A COPPER PLANE FOR ENHANCED THERMAL PERFORMANCE.

Figure 6. 16-Lead LFCSP Pin Configuration

Table 8. 16-Lead LFCSP Pin Function Descriptions

Pin No.	Mnemonic	Description
1	GND	Ground Pin, Logic Ground Reference.
2	A1	Terminal A of RDAC1. $V_{SS} \leq V_A \leq V_{DD}$ .
3	W1	Wiper Terminal of RDAC1. $V_{SS} \leq V_W \leq V_{DD}$ .
4	B1	Terminal B of RDAC1. $V_{SS} \leq V_B \leq V_{DD}$ .
5	$V_{SS}$	Negative Power Supply. Decouple this pin with 0.1 $\mu$ F ceramic capacitors and 10 $\mu$ F capacitors.
6	A2	Terminal A of RDAC2. $V_{SS} \leq V_A \leq V_{DD}$ .
7	W2	Wiper Terminal of RDAC2. $V_{SS} \leq V_W \leq V_{DD}$ .
8	B2	Terminal B of RDAC2. $V_{SS} \leq V_B \leq V_{DD}$ .
9	$V_{DD}$	Positive Power Supply. Decouple this pin with 0.1 $\mu$ F ceramic capacitors and 10 $\mu$ F capacitors.
10	$V_{LOGIC}$	Logic Power Supply; 1.8 V to $V_{DD}$ . Decouple this pin with 0.1 $\mu$ F ceramic capacitors and 10 $\mu$ F capacitors.
11	SCLK	Serial Clock Line. Data is clocked in at the logic low transition.
12	SDI	Serial Data Input.
13	SDO	Serial Data Output. This is an open-drain output pin, and it needs an external pull-up resistor.
14	$\overline{SYNC}$	Synchronization Input, Active Low. When $\overline{SYNC}$ returns high, data is loaded into the input shift register.
15	INDEP	Linear Gain Setting Mode at Power-Up. Each string resistor is loaded independently from the associated memory location. If INDEP is enabled, it cannot be disabled by software.
16	$\overline{RESET}$	Hardware Reset Pin. Refresh the RDAC registers from EEPROM. $\overline{RESET}$ is activated at the logic low. If this pin is not used, tie $\overline{RESET}$ to $V_{LOGIC}$ .
	EPAD	Exposed Pad. Connect this exposed pad to the potential of the $V_{SS}$ pin, or, alternatively, leave it electrically unconnected. It is recommended that the pad be thermally connected to a copper plane for enhanced thermal performance.

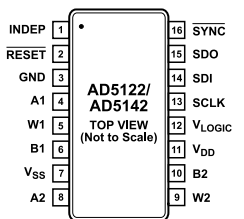


Figure 7. 16-Lead TSSOP, SPI Interface Pin Configuration

Table 9. 16-Lead TSSOP, SPI Interface Pin Function Descriptions

Pin No.	Mnemonic	Description
1	INDEP	Linear Gain Setting Mode at Power-Up. Each string resistor is loaded independently from the associated memory location. If INDEP is enabled, it cannot be disabled by software.
2	$\overline{RESET}$	Hardware Reset Pin. Refresh the RDAC registers from EEPROM. $\overline{RESET}$ is activated at the logic low. If this pin is not used, tie $\overline{RESET}$ to $V_{LOGIC}$ .
3	GND	Ground Pin, Logic Ground Reference.

## PIN CONFIGURATIONS AND FUNCTION DESCRIPTIONS

Table 9. 16-Lead TSSOP, SPI Interface Pin Function Descriptions (Continued)

Pin No.	Mnemonic	Description
4	A1	Terminal A of RDAC1. $V_{SS} \leq V_A \leq V_{DD}$ .
5	W1	Wiper Terminal of RDAC1. $V_{SS} \leq V_W \leq V_{DD}$ .
6	B1	Terminal B of RDAC1. $V_{SS} \leq V_B \leq V_{DD}$ .
7	V <sub>SS</sub>	Negative Power Supply. Decouple this pin with 0.1 $\mu$ F ceramic capacitors and 10 $\mu$ F capacitors.
8	A2	Terminal A of RDAC2. $V_{SS} \leq V_A \leq V_{DD}$ .
9	W2	Wiper Terminal of RDAC2. $V_{SS} \leq V_W \leq V_{DD}$ .
10	B2	Terminal B of RDAC2. $V_{SS} \leq V_B \leq V_{DD}$ .
11	V <sub>DD</sub>	Positive Power Supply. Decouple this pin with 0.1 $\mu$ F ceramic capacitors and 10 $\mu$ F capacitors.
12	V <sub>LOGIC</sub>	Logic Power Supply; 1.8 V to V <sub>DD</sub> . Decouple this pin with 0.1 $\mu$ F ceramic capacitors and 10 $\mu$ F capacitors.
13	SCLK	Serial Clock Line. Data is clocked in at the logic low transition.
14	SDI	Serial Data Input.
15	SDO	Serial Data Output. This is an open-drain output pin, and it needs an external pull-up resistor.
16	$\overline{\text{SYNC}}$	Synchronization Input, Active Low. When $\overline{\text{SYNC}}$ returns high, data is loaded into the input shift register.

TYPICAL PERFORMANCE CHARACTERISTICS

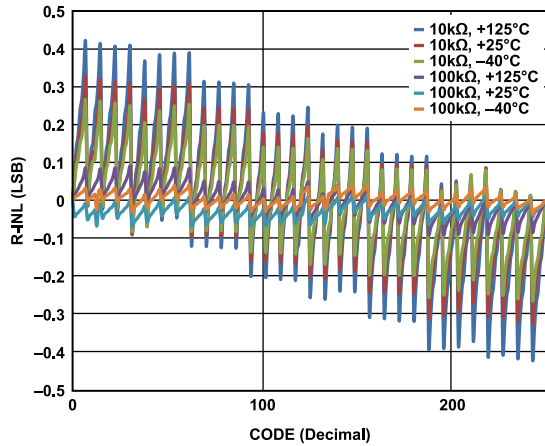


Figure 8. R-INL vs. Code (AD5142)

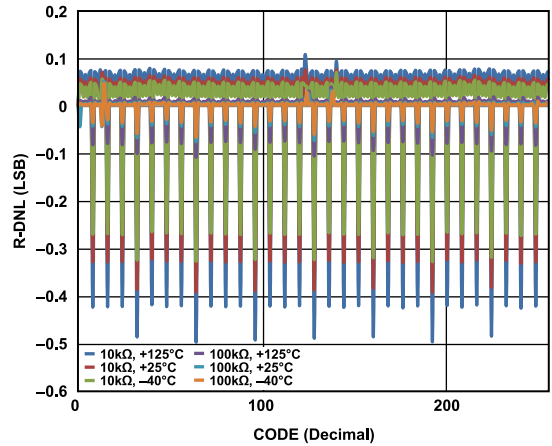


Figure 11. R-DNL vs. Code (AD5142)

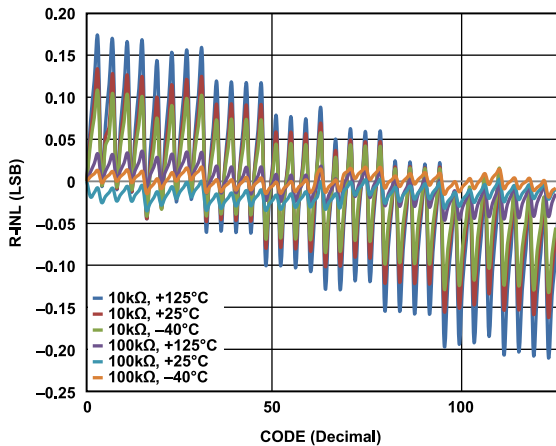


Figure 9. R-INL vs. Code (AD5122)

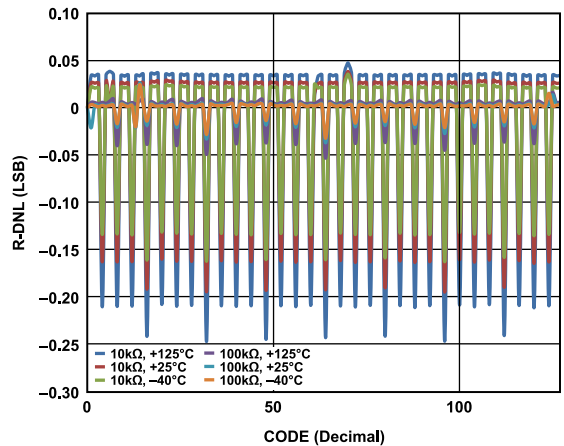


Figure 12. R-DNL vs. Code (AD5122)

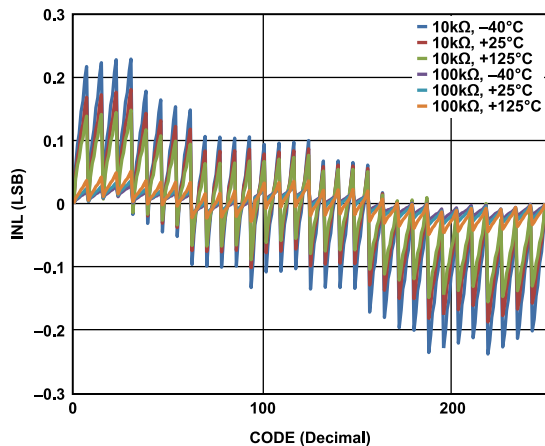


Figure 10. INL vs. Code (AD5142)

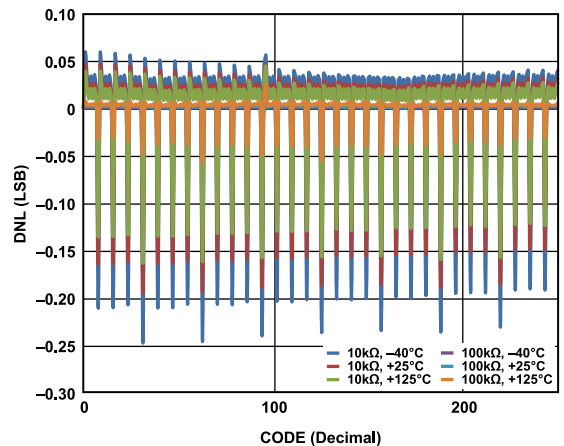


Figure 13. DNL vs. Code (AD5142)

TYPICAL PERFORMANCE CHARACTERISTICS

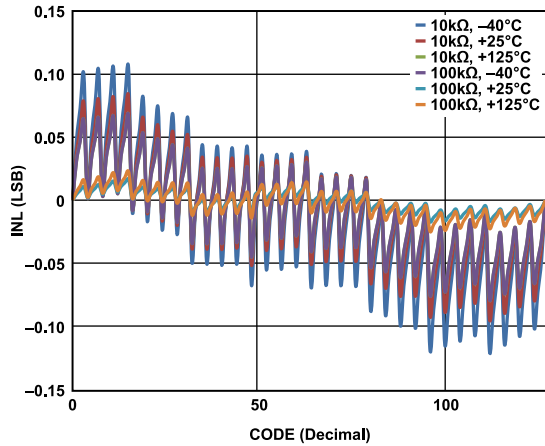


Figure 14. INL vs. Code (AD5122)

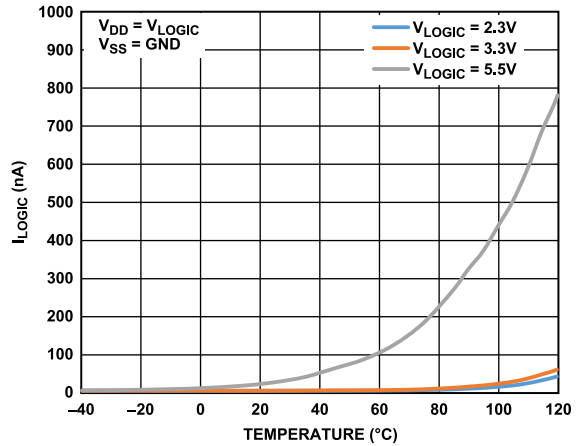


Figure 17. I<sub>LOGIC</sub> vs. Temperature

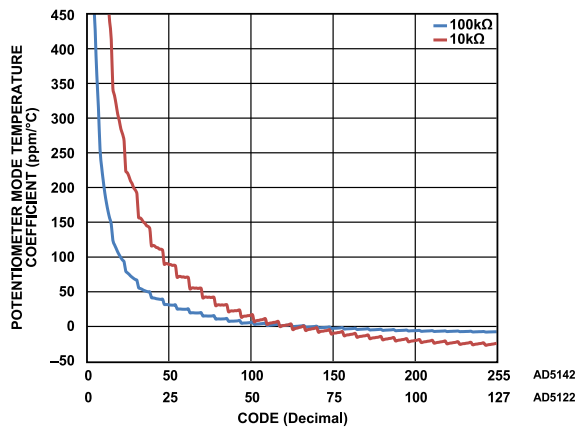


Figure 15. Potentiometer Mode Temperature Coefficient ( $(\Delta V_W/V_W)/\Delta T \times 10^6$ ) vs. Code

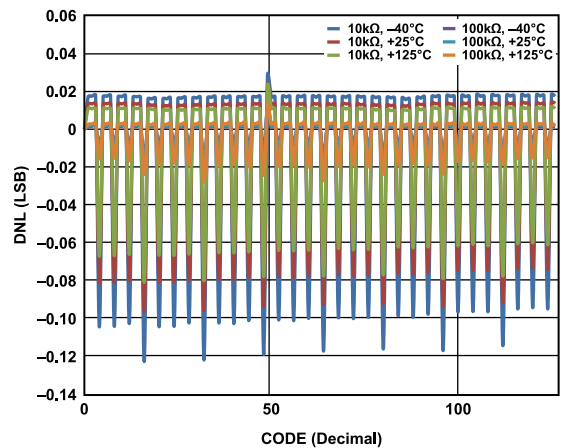


Figure 18. DNL vs. Code (AD5122)

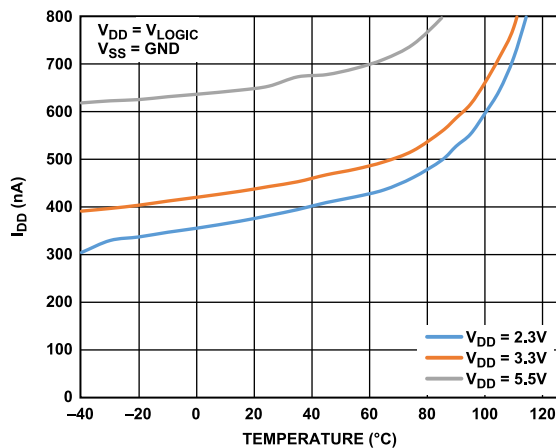


Figure 16. I<sub>DD</sub> vs. Temperature

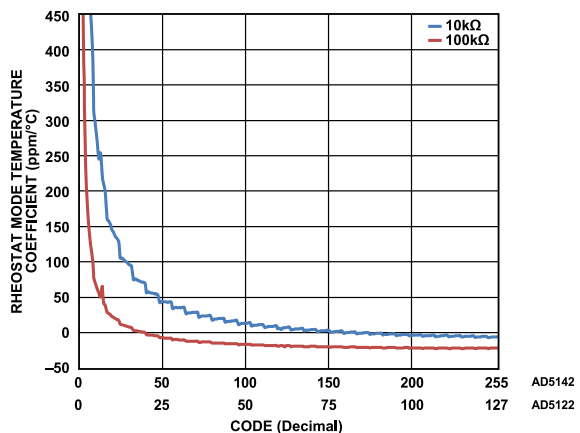


Figure 19. Rheostat Mode Temperature Coefficient ( $(\Delta R_{WB}/R_{WB})/\Delta T \times 10^6$ ) vs. Code

TYPICAL PERFORMANCE CHARACTERISTICS

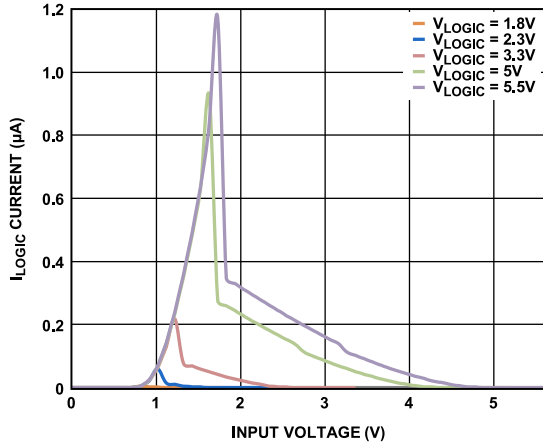


Figure 20.  $I_{LOGIC}$  Current vs. Digital Input Voltage

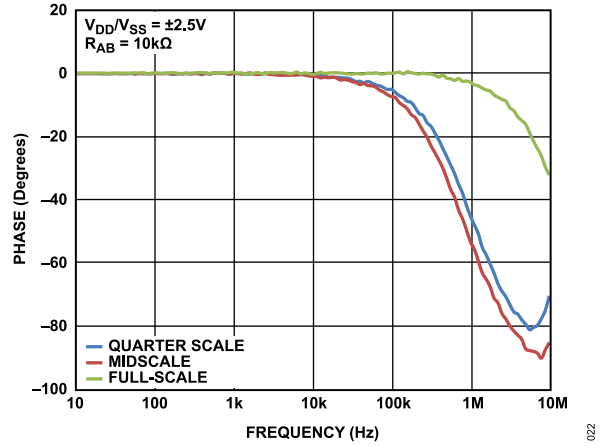


Figure 23. Normalized Phase Flatness vs. Frequency,  $R_{AB} = 10\text{ k}\Omega$

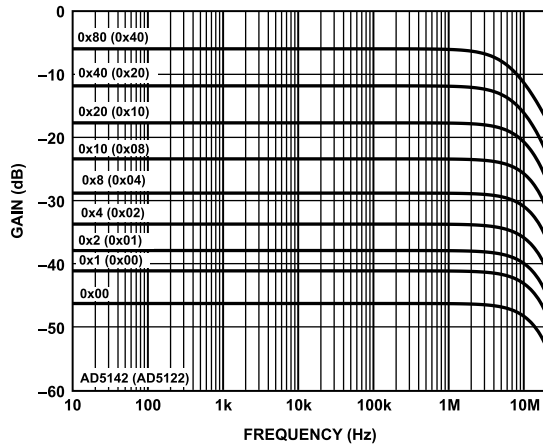


Figure 21.  $10\text{ k}\Omega$  Gain vs. Frequency vs. Code

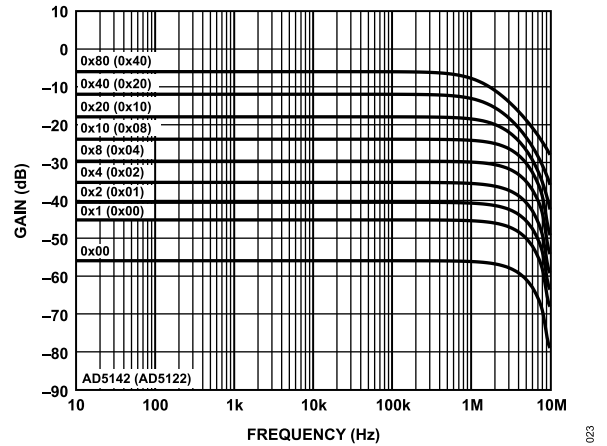


Figure 24.  $100\text{ k}\Omega$  Gain vs. Frequency vs. Code

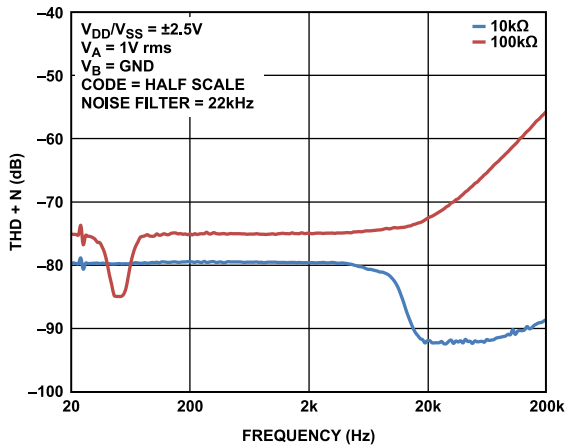


Figure 22. Total Harmonic Distortion Plus Noise (THD + N) vs. Frequency

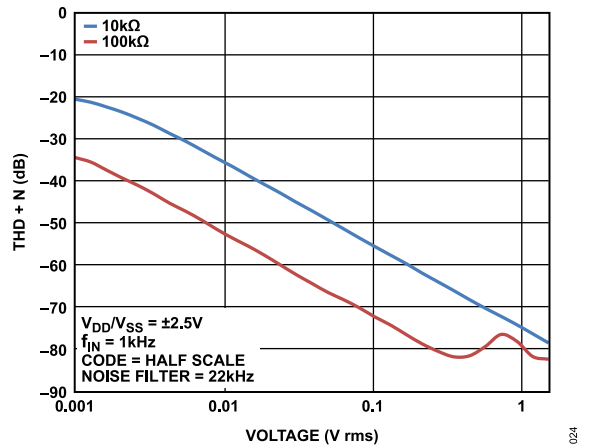


Figure 25. Total Harmonic Distortion Plus Noise (THD + N) vs. Amplitude

TYPICAL PERFORMANCE CHARACTERISTICS

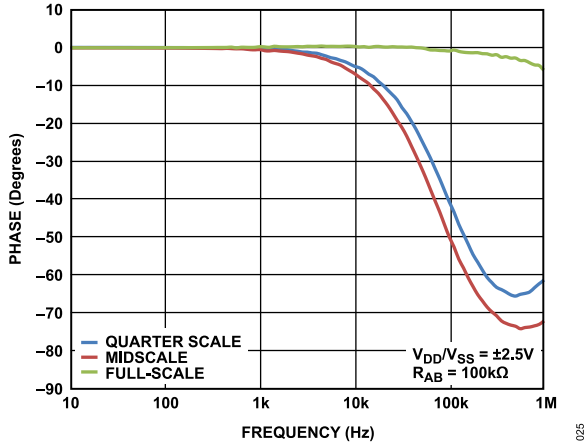


Figure 26. Normalized Phase Flatness vs. Frequency,  $R_{AB} = 100\text{ k}\Omega$

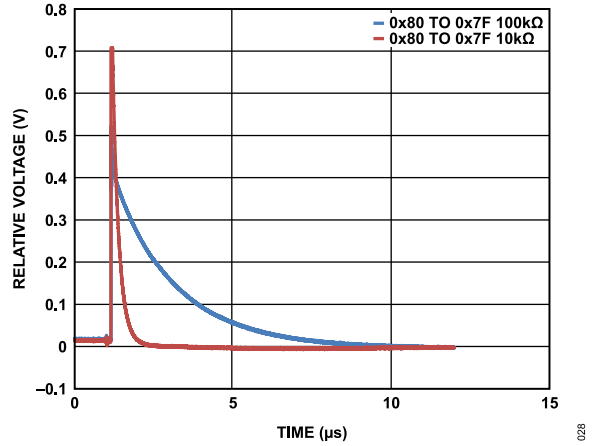


Figure 29. Maximum Transition Glitch

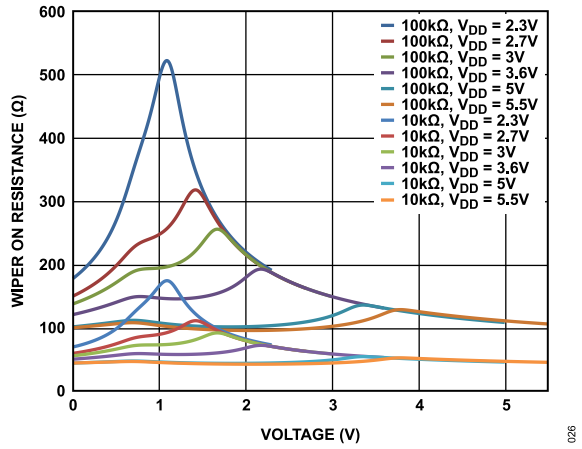


Figure 27. Incremental Wiper On Resistance vs. Positive Power Supply ( $V_{DD}$ )

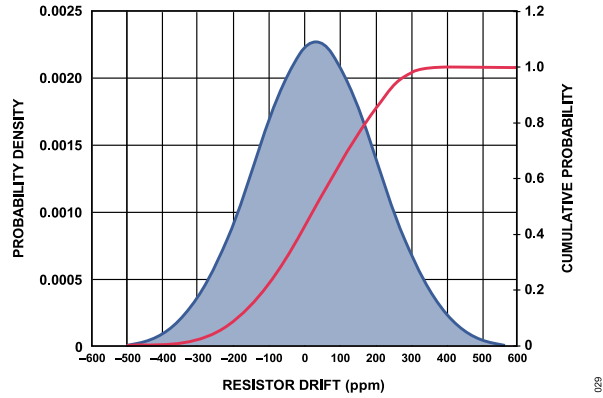


Figure 30. Resistor Lifetime Drift

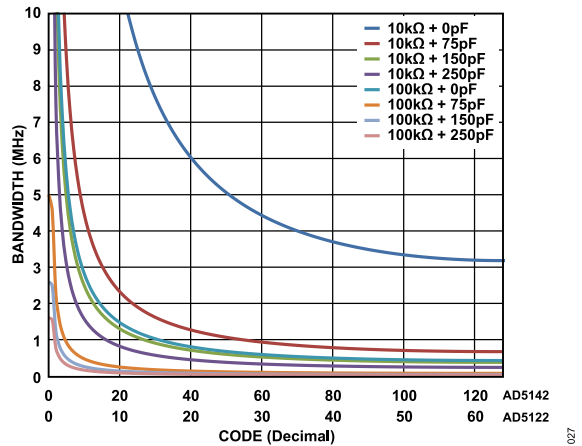


Figure 28. Maximum Bandwidth vs. Code vs. Net Capacitance

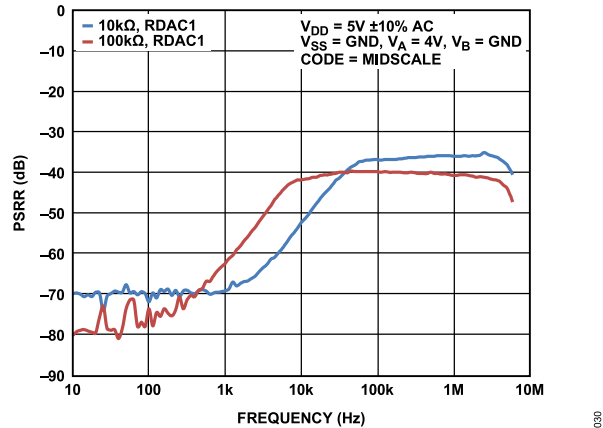


Figure 31. Power Supply Rejection Ratio (PSRR) vs. Frequency

TYPICAL PERFORMANCE CHARACTERISTICS

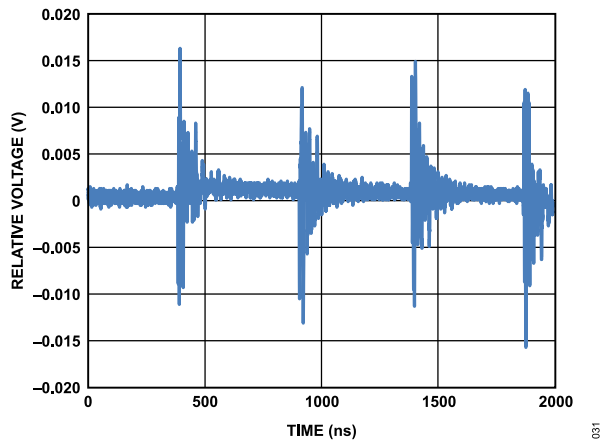


Figure 32. Digital Feedthrough

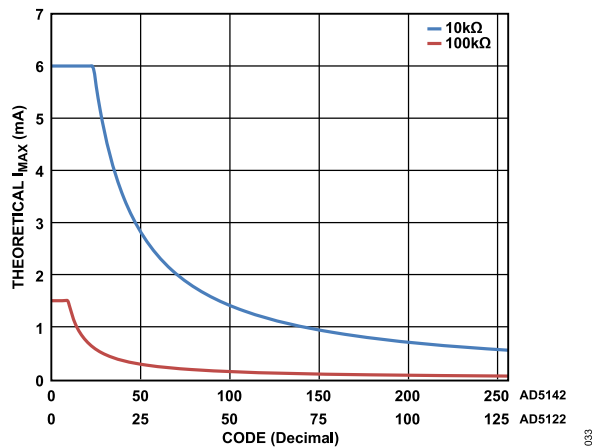


Figure 34. Theoretical Maximum Current vs. Code

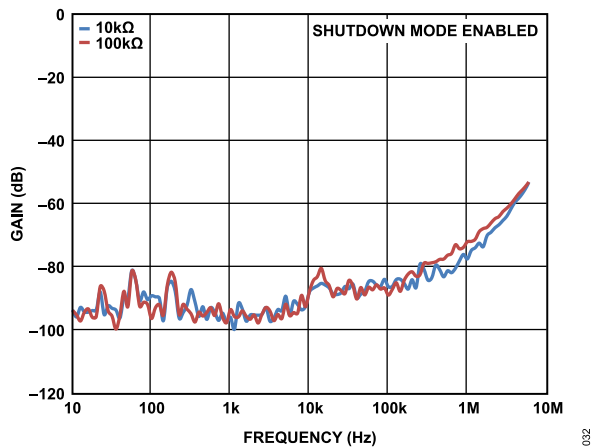


Figure 33. Shutdown Isolation vs. Frequency

TEST CIRCUITS

Figure 35 to Figure 39 define the test conditions used in the Specifications section.

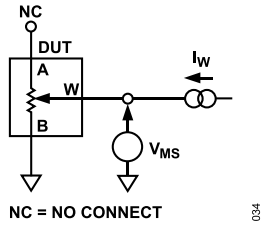


Figure 35. Resistor Integral Nonlinearity Error (Rheostat Operation; R-INL, R-DNL)

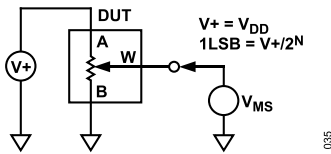


Figure 36. Potentiometer Divider Nonlinearity Error (INL, DNL)

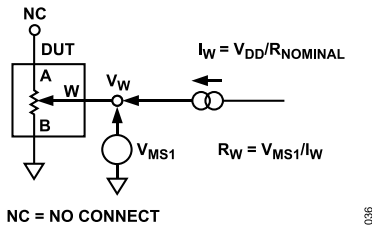


Figure 37. Wiper Resistance

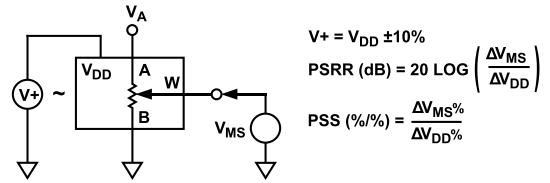


Figure 38. Power Supply Sensitivity and Power Supply Rejection Ratio (PSS, PSRR)

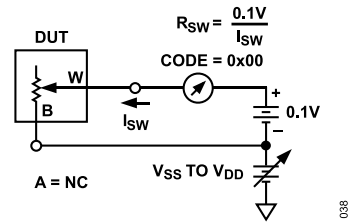


Figure 39. Incremental On Resistance

## THEORY OF OPERATION

The AD5122/AD5142 digital programmable potentiometers are designed to operate as true variable resistors for analog signals within the terminal voltage range of  $V_{SS} < V_{TERM} < V_{DD}$ . The resistor wiper position is determined by the RDAC register contents. The RDAC register acts as a scratchpad register that allows unlimited changes of resistance settings. A secondary register (the input register) can preload the RDAC register data.

The RDAC register can be programmed with any position setting using the SPI interface (depending on the model). When a desirable wiper position is found, this value can be stored in the EEPROM memory. Thereafter, the wiper position is always restored to that position for subsequent power-ups. The storing of EEPROM data takes approximately 15 ms; during this time, the device is locked and does not acknowledge any new command, preventing any changes from taking place.

### RDAC REGISTER AND EEPROM

The RDAC register directly controls the position of the digital potentiometer wiper. For example, when the RDAC register is loaded with 0x80 (AD5142, 256 taps), the wiper is connected to half scale of the variable resistor. The RDAC register is a standard logic register; there is no restriction on the number of changes allowed.

It is possible to both write to and read from the RDAC register using the digital interface (see [Table 10](#)).

The contents of the RDAC register can be stored to the EEPROM using Command 9 (see [Table 16](#)). Thereafter, the RDAC register always sets at that position for any future on-off-on power supply sequence. It is possible to read back data saved into the EEPROM with Command 3 (see [Table 10](#)).

Alternatively, the EEPROM can be written to independently using Command 11 (see [Table 16](#)).

### INPUT SHIFT REGISTER

For the AD5122/AD5142, the input shift register is 16 bits wide, as shown in [Figure 2](#). The 16-bit word consists of four control bits, followed by four address bits and by eight data bits.

If the AD5122 RDAC or EEPROM registers are read from or written to, the lowest data bit (Bit 0) is ignored.

Data is loaded MSB first (Bit 15). The four control bits determine the function of the software command as listed in [Table 10](#) and [Table 16](#).

### SPI SERIAL DATA INTERFACE

The AD5122/AD5142 contain a 4-wire, SPI-compatible digital interface (SDI,  $\overline{\text{SYNC}}$ , SDO, and SCLK). The write sequence begins by

bringing the  $\overline{\text{SYNC}}$  line low. The  $\overline{\text{SYNC}}$  pin must be held low until the complete data-word is loaded from the SDI pin. Data is loaded in at the SCLK falling edge transition, as shown in [Figure 3](#) and [Figure 4](#). When  $\overline{\text{SYNC}}$  returns high, the serial data-word is decoded according to the instructions in [Table 16](#).

To minimize power consumption in the digital input buffers when the device is enabled, operate all serial interface pins close to the  $V_{\text{LOGIC}}$  supply rails.

### $\overline{\text{SYNC}}$ Interruption

In a standalone write sequence for the AD5122/AD5142, the  $\overline{\text{SYNC}}$  line is kept low for 16 falling edges of SCLK, and the instruction is decoded when  $\overline{\text{SYNC}}$  is pulled high. However, if the  $\overline{\text{SYNC}}$  line is kept low for less than 16 falling edges of SCLK, the input shift register content is ignored, and the write sequence is considered invalid.

### SDO Pin

The serial data output pin (SDO) serves two purposes: to read back the contents of the control, EEPROM, RDAC, and input registers using Command 3 (see [Table 10](#) and [Table 16](#)), and to connect the AD5122/AD5142 to daisy-chain mode.

The SDO pin contains an internal open-drain output that needs an external pull-up resistor. The SDO pin is enabled when  $\overline{\text{SYNC}}$  is pulled low, and the data is clocked out of SDO on the rising edge of SCLK, as shown in [Figure 3](#) and [Figure 4](#).

### Daisy-Chain Connection

Daisy chaining minimizes the number of port pins required from the controlling IC. As shown in [Figure 40](#), the SDO pin of one package must be tied to the SDI pin of the next package. The clock period can be increased because of the propagation delay of the line between subsequent devices. When two AD5122/AD5142 devices are daisy chained, 32 bits of data are required. The first 16 bits assigned to U2, and the second 16 bits assigned to U1, as shown in [Figure 41](#). Keep the  $\overline{\text{SYNC}}$  pin low until all 32 bits are clocked into their respective serial registers. The  $\overline{\text{SYNC}}$  pin is then pulled high to complete the operation. A typical connection is shown in [Figure 40](#).

To prevent data from mislocking (for example, due to noise) the device includes an internal counter, if the clock falling edges count is not a multiple of 8, the device ignores the command. A valid clock count is 16, 24, or 32. The counter resets when  $\overline{\text{SYNC}}$  returns high.

THEORY OF OPERATION

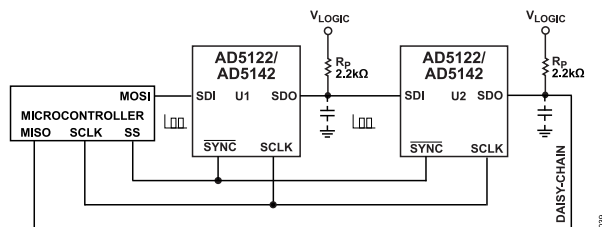


Figure 40. Daisy-Chain Configuration

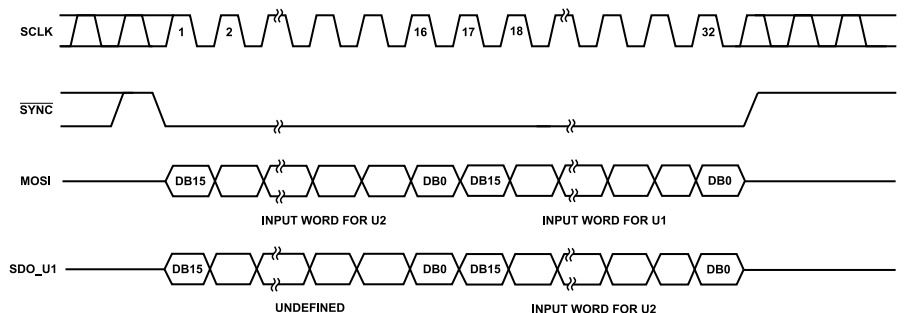


Figure 41. Daisy-Chain Diagram

Table 10. Reduced Commands Operation Truth Table

Command Number	Control Bits[DB15:DB12]				Address Bits[DB11:DB8] <sup>1</sup>				Data Bits[DB7:DB0] <sup>1</sup>								Operation									
	C3	C2	C1	C0	A3	A2	A1	A0	D7	D6	D5	D4	D3	D2	D1	D0										
0	0	0	0	0	X	X	X	X	X	X	X	X	X	X	X	X	NOP: do nothing.									
1	0	0	0	1	0	0	0	A0	D7	D6	D5	D4	D3	D2	D1	D0	Write contents of serial register data to RDAC									
2	0	0	1	0	0	0	0	A0	D7	D6	D5	D4	D3	D2	D1	D0	Write contents of serial register data to input register									
3	0	0	1	1	X	0	A1	A0	X	X	X	X	X	X	D1	D0	Read back contents									
																	<table border="1"> <thead> <tr> <th>D1</th> <th>D0</th> <th>Data</th> </tr> </thead> <tbody> <tr> <td>0</td> <td>1</td> <td>EEPROM</td> </tr> <tr> <td>1</td> <td>1</td> <td>RDAC</td> </tr> </tbody> </table>	D1	D0	Data	0	1	EEPROM	1	1	RDAC
D1	D0	Data																								
0	1	EEPROM																								
1	1	RDAC																								
9	0	1	1	1	0	0	0	A0	X	X	X	X	X	X	X	1	Copy RDAC register to EEPROM									
10	0	1	1	1	0	0	0	A0	X	X	X	X	X	X	X	0	Copy EEPROM into RDAC									
14	1	0	1	1	X	X	X	X	X	X	X	X	X	X	X	X	Software reset									
15	1	1	0	0	A3	0	0	A0	X	X	X	X	X	X	X	D0	Software shutdown									
																	<table border="1"> <thead> <tr> <th>D0</th> <th>Condition</th> </tr> </thead> <tbody> <tr> <td>0</td> <td>Normal mode</td> </tr> <tr> <td>1</td> <td>Shutdown mode</td> </tr> </tbody> </table>	D0	Condition	0	Normal mode	1	Shutdown mode			
D0	Condition																									
0	Normal mode																									
1	Shutdown mode																									

<sup>1</sup> X means don't care.

Table 11. Reduced Address Bits Table

A3	A2	A1	A0	Channel	Stored Channel Memory
1	X <sup>1</sup>	X <sup>1</sup>	X <sup>1</sup>	All channels	Not applicable
0	0	0	0	RDAC1	RDAC1
0	0	0	1	RDAC2	Not applicable
0	0	1	0	Not applicable	RDAC2

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<sup>1</sup> X means don't care.

### ADVANCED CONTROL MODES

The AD5122/AD5142 digital potentiometers include a set of user programming features to address the wide number of applications for these universal adjustment devices (see [Table 16](#) and [Table 18](#)).

Key programming features include the following:

- ▶ Input register
- ▶ Linear gain setting mode
- ▶ Low wiper resistance feature
- ▶ Lineal increment and decrement instructions
- ▶  $\pm 6$  dB increment and decrement instructions
- ▶ Reset
- ▶ Shutdown mode

### Input Register

The AD5122/AD5142 include one input register per RDAC register. These registers allow preloading of the value for the associated RDAC register. These registers can be written to using Command 2 and read back from using Command 3 (see [Table 16](#)).

This feature allows a synchronous update of one or all the RDAC registers at the same time.

The transfer from the input register to the RDAC register is done synchronously by Command 8 (see [Table 16](#)).

If new data is loaded into an RDAC register, this RDAC register automatically overwrites the associated input register.

### Linear Gain Setting Mode

The proprietary architecture of the AD5122/AD5142 allows the independent control of each string resistor,  $R_{AW}$  and  $R_{WB}$ . To enable this feature, use Command 16 (see [Table 16](#)) to set Bit D2 of the control register (see [Table 18](#)).

This mode of operation can control the potentiometer as two independent rheostats connected at a single point, W terminal, as opposed to potentiometer mode where each resistor is complementary,  $R_{AW} = R_{AB} - R_{WB}$ .

This feature enables a second input and an RDAC register per channel, as shown in [Table 17](#); however, the actual RDAC contents remain unchanged. The same operations are valid for potentiometer mode and linear gain setting mode.

If the INDEP pin is pulled high, the device powers up in linear gain setting mode and loads the values stored in the associated memory locations for each channel (see [Table 17](#)). The INDEP pin and D2 bit are connected internally to a logic or gate, if any or both are 1, the devices cannot operate in potentiometer mode.

### Low Wiper Resistance Feature

The AD5122/AD5142 include two commands to reduce the wiper resistance between the terminals when the devices achieve full scale or zero scale. These extra positions are called bottom scale, BS, and top scale, TS. The resistance between Terminal A and Terminal W at top scale is specified as  $R_{TS}$ . Similarly, the bottom scale resistance between Terminal B and Terminal W is specified as  $R_{BS}$ .

The contents of the RDAC registers are unchanged by entering in these positions. There are three ways to exit from top scale and bottom scale: by using Command 12 or Command 13 (see [Table 16](#)); by loading new data in an RDAC register, which includes increment/decrement operations; or by entering shutdown mode, Command 15 (see [Table 16](#)).

[Table 12](#) and [Table 13](#) show the truth tables for the top scale position and the bottom scale position, respectively, when the potentiometer or linear gain setting mode is enabled.

**Table 12. Top Scale Truth Table**

Linear Gain Setting Mode		Potentiometer Mode	
$R_{AW}$	$R_{WB}$	$R_{AW}$	$R_{WB}$
$R_{AB}$	$R_{AB}$	$R_{TS}$	$R_{AB}$

**Table 13. Bottom Scale Truth Table**

Linear Gain Setting Mode		Potentiometer Mode	
$R_{AW}$	$R_{WB}$	$R_{AW}$	$R_{WB}$
$R_{TS}$	$R_{BS}$	$R_{AB}$	$R_{BS}$

### Linear Increment and Decrement Instructions

The increment and decrement commands (Command 4 and Command 5 in [Table 16](#)) are useful for linear step adjustment applications. These commands simplify microcontroller software coding by allowing the controller to send an increment or decrement command to the device. The adjustment can be individual or in a ganged potentiometer arrangement, where all wiper positions are changed at the same time.

For an increment command, executing Command 4 automatically moves the wiper to the next RDAC position. This command can be executed in a single channel or multiple channels.

### $\pm 6$ dB Increment and Decrement Instructions

Two programming instructions produce logarithmic taper increment or decrement of the wiper position control by an individual potentiometer or by a ganged potentiometer arrangement where all RDAC register positions are changed simultaneously. The +6 dB increment is activated by Command 6, and the -6 dB decrement is activated by Command 7 (see [Table 16](#)). For example, starting with the zero-scale position and executing Command 6 ten times

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moves the wiper in 6 dB steps to the full-scale position. When the wiper position is near the maximum setting, the last 6 dB increment instruction causes the wiper to go to the full-scale position (see Table 14).

Incrementing the wiper position by +6 dB essentially doubles the RDAC register value, whereas decrementing the wiper position by -6 dB halves the register value. Internally, the AD5122/AD5142 use shift registers to shift the bits left and right to achieve a  $\pm 6$  dB increment or decrement. These functions are useful for various audio/video level adjustments, especially for white LED brightness settings in which human visual responses are more sensitive to large adjustments than to small adjustments.

**Table 14. Detailed Left Shift and Right Shift Functions for the  $\pm 6$  dB Step Increment and Decrement**

Left Shift (+6 dB/Step)	Right Shift (-6 dB/Step)
0000 0000	1111 1111
0000 0001	0111 1111
0000 0010	0011 1111
0000 0100	0001 1111
0000 1000	0000 1111
0001 0000	0000 0111
0010 0000	0000 0011
0100 0000	0000 0001
1000 0000	0000 0000
1111 1111	0000 0000

## Reset

The AD5122/AD5142 can be reset through software by executing Command 14 (see Table 16) or through hardware on the low pulse of the  $\overline{\text{RESET}}$  pin. The reset command loads the RDAC registers with the contents of the EEPROM and takes approximately 30  $\mu\text{s}$ . The EEPROM is preloaded to midscale at the factory, and initial power-up is, accordingly, at midscale. Tie  $\overline{\text{RESET}}$  to  $V_{\text{LOGIC}}$  if the  $\overline{\text{RESET}}$  pin is not used.

**Table 16. Advance Command Operation Truth Table**

Command Number	Control Bits[DB15:DB12]				Address Bits[DB11:DB8] <sup>1</sup>				Data Bits[DB7:DB0] <sup>1</sup>								Operation															
	C3	C2	C1	C0	A3	A2	A1	A0	D7	D6	D5	D4	D3	D2	D1	D0																
0	0	0	0	0	X	X	X	X	X	X	X	X	X	X	X	X	NOP: do nothing															
1	0	0	0	1	0	A2	0	A0	D7	D6	D5	D4	D3	D2	D1	D0	Write contents of serial register data to RDAC															
2	0	0	1	0	0	A2	0	A0	D7	D6	D5	D4	D3	D2	D1	D0	Write contents of serial register data to input register															
3	0	0	1	1	0	A2	A1	A0	X	X	X	X	X	X	D1	D0	Read back contents															
																	<table border="1"> <thead> <tr> <th>D1</th> <th>D0</th> <th>Data</th> </tr> </thead> <tbody> <tr><td>0</td><td>0</td><td>Input register</td></tr> <tr><td>0</td><td>1</td><td>EEPROM</td></tr> <tr><td>1</td><td>0</td><td>Control register</td></tr> <tr><td>1</td><td>1</td><td>RDAC</td></tr> </tbody> </table>	D1	D0	Data	0	0	Input register	0	1	EEPROM	1	0	Control register	1	1	RDAC
D1	D0	Data																														
0	0	Input register																														
0	1	EEPROM																														
1	0	Control register																														
1	1	RDAC																														
4	0	1	0	0	A3	A2	0	A0	X	X	X	X	X	X	X	1	Linear RDAC increment															
5	0	1	0	0	A3	A2	0	A0	X	X	X	X	X	X	X	0	Linear RDAC decrement															

## Shutdown Mode

The AD5122/AD5142 can be placed in shutdown mode by executing the software shutdown command, Command 15 (see Table 16); and by setting the LSB (D0) to 1. This feature places the RDAC in a special state. The contents of the RDAC register are unchanged by entering shutdown mode. However, all commands listed in Table 16 are supported while in shutdown mode. Execute Command 15 (see Table 16) and set the LSB (D0) to 0 to exit shutdown mode.

**Table 15. Truth Table for Shutdown Mode**

A2	Linear Gain Setting Mode		Potentiometer Mode	
	AW	WB	AW	WB
0	N/A <sup>1</sup>	Open	Open	$R_{\text{BS}}$
1	Open	N/A <sup>1</sup>	N/A <sup>1</sup>	N/A <sup>1</sup>

<sup>1</sup> N/A means not applicable.

## EEPROM OR RDAC REGISTER PROTECTION

The EEPROM and RDAC registers can be protected by disabling any update to these registers. This can be done by using software. If these registers are protected by software, set Bit D0 and/or Bit D1 (see Table 18), which protects the EEPROM and RDAC registers independently.

When RDAC is protected, the only operation allowed is to copy the EEPROM into the RDAC register.

## INDEP PIN

If the INDEP pin is pulled high at power-up, the device operates in linear gain setting mode, loading each string resistor,  $R_{\text{AWx}}$  and  $R_{\text{WBx}}$ , with the value stored into the EEPROM (see Table 17). If the pin is pulled low, the device powers up in potentiometer mode.

The INDEP pin and the D2 bit are connected internally to a logic OR gate, if any or both are 1, the device cannot operate in potentiometer mode (see Table 18).

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Table 16. Advance Command Operation Truth Table (Continued)

Command Number	Control Bits[DB15:DB12]				Address Bits[DB11:DB8] <sup>1</sup>				Data Bits[DB7:DB0] <sup>1</sup>								Operation
	C3	C2	C1	C0	A3	A2	A1	A0	D7	D6	D5	D4	D3	D2	D1	D0	
6	0	1	0	1	A3	A2	0	A0	X	X	X	X	X	X	X	1	+6 dB RDAC increment
7	0	1	0	1	A3	A2	0	A0	X	X	X	X	X	X	X	0	-6 dB RDAC decrement
8	0	1	1	0	A3	A2	0	A0	X	X	X	X	X	X	X	X	Copy input register to RDAC (software LRDAC)
9	0	1	1	1	0	A2	0	A0	X	X	X	X	X	X	X	1	Copy RDAC register to EEPROM
10	0	1	1	1	0	A2	0	A0	X	X	X	X	X	X	X	0	Copy EEPROM into RDAC
11	1	0	0	0	0	0	A1	A0	D7	D6	D5	D4	D3	D2	D1	D0	Write contents of serial register data to EEPROM
12	1	0	0	1	A3	A2	0	A0	1	0	0	0	0	0	0	D0	Top scale D0 = 0; normal mode D0 = 1; shutdown mode
13	1	0	0	1	A3	A2	0	A0	0	0	0	0	0	0	0	D0	Bottom scale D0 = 1; enter D0 = 0; exit
14	1	0	1	1	X	X	X	X	X	X	X	X	X	X	X	X	Software reset
15	1	1	0	0	A3	A2	0	A0	0	0	0	0	0	0	0	D0	Software shutdown D0 = 0; normal mode D0 = 1; device placed in shutdown mode
16	1	1	0	1	X	X	X	X	X	X	X	X	X	D2	D1	D0	Copy serial register data to control register

<sup>1</sup> X means don't care.

Table 17. Address Bits

A3	A2	A1	A0	Potentiometer Mode		Linear Gain Setting Mode		Stored Channel Memory
				Input Register	RDAC Register	Input Register	RDAC Register	
1	X <sup>1</sup>	X <sup>1</sup>	X <sup>1</sup>	All channels	All channels	All channels	All channels	Not applicable
0	0	0	0	RDAC1	RDAC1	R <sub>WB1</sub>	R <sub>WB1</sub>	RDAC1/R <sub>WB1</sub>
0	1	0	0	Not applicable	Not applicable	R <sub>AW1</sub>	R <sub>AW1</sub>	Not applicable
0	0	0	1	RDAC2	RDAC2	R <sub>WB2</sub>	R <sub>WB2</sub>	R <sub>AW1</sub>
0	1	0	1	Not applicable	Not applicable	R <sub>AW2</sub>	R <sub>AW2</sub>	Not applicable
0	0	1	0	Not applicable	Not applicable	Not applicable	Not applicable	RDAC2/R <sub>WB2</sub>
0	0	1	1	Not applicable	Not applicable	Not applicable	Not applicable	R <sub>AW2</sub>

<sup>1</sup> X means don't care.

Table 18. Control Register Bit Descriptions

Bit Name	Description
D0	RDAC register write protect 0 = wiper position frozen to value in EEPROM memory 1 = allows update of wiper position through digital interface (default)
D1	EEPROM program enable 0 = EEPROM program disabled 1 = enables device for EEPROM program (default)
D2	Lineal setting mode/potentiometer mode 0 = potentiometer mode (default) 1 = linear gain setting mode

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### RDAC ARCHITECTURE

To achieve optimum performance, Analog Devices, Inc., uses a proprietary RDAC segmentation architecture for all the digital potentiometers. In particular, the AD5122/AD5142 employ a three stage segmentation approach, as shown in Figure 42. The AD5122/AD5142 wiper switch is designed with the transmission gate CMOS topology and with the gate voltage derived from  $V_{DD}$  and  $V_{SS}$ .

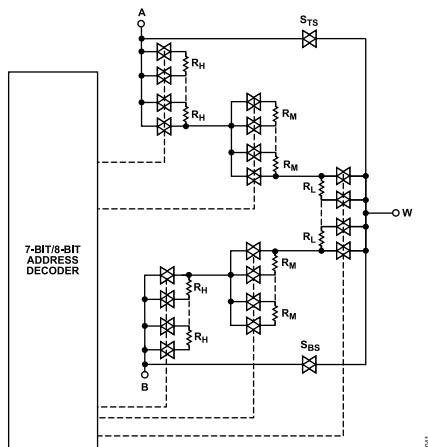


Figure 42. AD5122/AD5142 Simplified RDAC Circuit

### Top Scale/Bottom Scale Architecture

In addition, the AD5122/AD5142 include new positions to reduce the resistance between terminals. These positions are called bottom scale and top scale. At bottom scale, the typical wiper resistance decreases from 130  $\Omega$  to 60  $\Omega$  ( $R_{AB} = 100$  k $\Omega$ ). At top scale, the resistance between Terminal A and Terminal W is decreased by 1 LSB, and the total resistance is reduced to 60  $\Omega$  ( $R_{AB} = 100$  k $\Omega$ ).

### PROGRAMMING THE VARIABLE RESISTOR

#### Rheostat Operation— $\pm 8\%$ Resistor Tolerance

The AD5122/AD5142 operate in rheostat mode when only two terminals are used as a variable resistor. The unused terminal can be floating, or it can be tied to Terminal W, as shown in Figure 43.

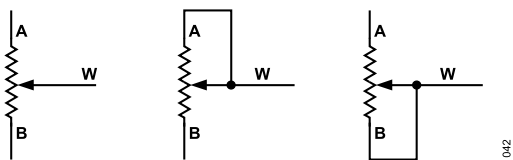


Figure 43. Rheostat Mode Configuration

The nominal resistance between Terminal A and Terminal B,  $R_{AB}$ , is 10 k $\Omega$  or 100 k $\Omega$ , and has 128/256 tap points accessed by the wiper terminal. The 7-bit/8-bit data in the RDAC latch is decoded to select one of the 128/256 possible wiper settings. The general equations for determining the digitally programmed output resistance between Terminal W and Terminal B are

AD5122:

$$R_{WB}(D) = \frac{D}{128} \times R_{AB} + R_W \quad \text{From } 0x00 \text{ to } 0x7F \quad (1)$$

AD5142:

$$R_{WB}(D) = \frac{D}{256} \times R_{AB} + R_W \quad \text{From } 0x00 \text{ to } 0xFF \quad (2)$$

where:

$D$  is the decimal equivalent of the binary code in the 7-bit/8-bit RDAC register.

$R_{AB}$  is the end-to-end resistance.

$R_W$  is the wiper resistance.

In potentiometer mode, similar to the mechanical potentiometer, the resistance between Terminal W and Terminal A also produces a digitally controlled complementary resistance,  $R_{WA}$ .  $R_{WA}$  also gives a maximum of 8% absolute resistance error.  $R_{WA}$  starts at the maximum resistance value and decreases as the data loaded into the latch increases. The general equations for this operation are

AD5122:

$$R_{AW}(D) = \frac{128-D}{128} \times R_{AB} + R_W \quad \text{From } 0x00 \text{ to } 0x7F \quad (3)$$

AD5142:

$$R_{AW}(D) = \frac{256-D}{256} \times R_{AB} + R_W \quad \text{From } 0x00 \text{ to } 0xFF \quad (4)$$

where:

$D$  is the decimal equivalent of the binary code in the 7-bit/8-bit RDAC register.

$R_{AB}$  is the end-to-end resistance.

$R_W$  is the wiper resistance.

If the device is configured in linear gain setting mode, the resistance between Terminal W and Terminal A is directly proportional to the code loaded in the associate RDAC register. The general equations for this operation are

AD5122:

$$R_{AW}(D) = \frac{D}{128} \times R_{AB} + R_W \quad \text{From } 0x00 \text{ to } 0x7F \quad (5)$$

AD5142:

$$R_{AW}(D) = \frac{D}{256} \times R_{AB} + R_W \quad \text{From } 0x00 \text{ to } 0xFF \quad (6)$$

where:

$D$  is the decimal equivalent of the binary code in the 7-bit/8-bit RDAC register.

$R_{AB}$  is the end-to-end resistance.

## THEORY OF OPERATION

$R_W$  is the wiper resistance.

In the bottom scale condition or top scale condition, a finite total wiper resistance of  $40\ \Omega$  is present. Regardless of which setting the device is operating in, limit the current between Terminal A to Terminal B, Terminal W to Terminal A, and Terminal W to Terminal B, to the maximum continuous current of  $\pm 6\ \text{mA}$  or to the pulse current specified in Table 6. Otherwise, degradation or possible destruction of the internal switch contact can occur.

## PROGRAMMING THE POTENTIOMETER DIVIDER

### Voltage Output Operation

The digital potentiometer easily generates a voltage divider at wiper to B and wiper to A that is proportional to the input voltage at A to B, as shown in Figure 44.

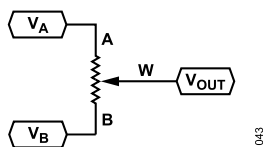


Figure 44. Potentiometer Mode Configuration

Connecting Terminal A to 5 V and Terminal B to ground produces an output voltage at the Wiper W to Terminal B ranging from 0 V to 5 V. The general equation defining the output voltage at  $V_W$  with respect to ground for any valid input voltage applied to Terminal A and Terminal B is

$$V_W(D) = \frac{R_{WB}(D)}{R_{AB}} \times V_A + \frac{R_{AW}(D)}{R_{AB}} \times V_B \quad (7)$$

where:

$R_{WB}(D)$  can be obtained from Equation 1 and Equation 2.

$R_{AW}(D)$  can be obtained from Equation 3 and Equation 4.

Operation of the digital potentiometer in the divider mode results in a more accurate operation over temperature. Unlike the rheostat mode, the output voltage is dependent mainly on the ratio of the internal resistors,  $R_{AW}$  and  $R_{WB}$ , and not the absolute values. Therefore, the temperature drift reduces to  $5\ \text{ppm}/^\circ\text{C}$ .

### TERMINAL VOLTAGE OPERATING RANGE

The AD5122/AD5142 are designed with internal ESD diodes for protection. These diodes also set the voltage boundary of the terminal operating voltages. Positive signals present on Terminal A, Terminal B, or Terminal W that exceed  $V_{DD}$  are clamped by the forward-biased diode. There is no polarity constraint between  $V_A$ ,  $V_W$ , and  $V_B$ , but they cannot be higher than  $V_{DD}$  or lower than  $V_{SS}$ .

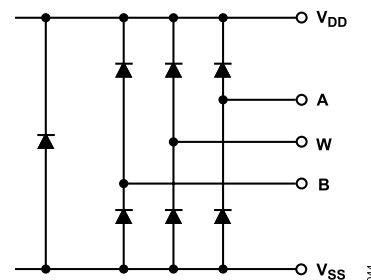


Figure 45. Maximum Terminal Voltages Set by  $V_{DD}$  and  $V_{SS}$

### POWER-UP SEQUENCE

Because there are diodes to limit the voltage compliance at Terminal A, Terminal B, and Terminal W (see Figure 45), it is important to power up  $V_{DD}$  first before applying any voltage to Terminal A, Terminal B, and Terminal W. Otherwise, the diode is forward-biased such that  $V_{DD}$  is powered unintentionally. The ideal power-up sequence is  $V_{SS}$ ,  $V_{DD}$ ,  $V_{LOGIC}$ , digital inputs, and  $V_A$ ,  $V_B$ , and  $V_W$ . The order of powering  $V_A$ ,  $V_B$ ,  $V_W$ , and digital inputs is not important as long as they are powered after  $V_{SS}$ ,  $V_{DD}$ , and  $V_{LOGIC}$ . Regardless of the power-up sequence and the ramp rates of the power supplies, once  $V_{LOGIC}$  is powered, the power-on preset activates, which restores EEPROM values to the RDAC registers.

### LAYOUT AND POWER SUPPLY BIASING

It is always a good practice to use a compact, minimum lead length layout design. Ensure that the leads to the input are as direct as possible with a minimum conductor length. Ground paths must have low resistance and low inductance. It is also good practice to bypass the power supplies with quality capacitors. Apply low equivalent series resistance (ESR)  $1\ \mu\text{F}$  to  $10\ \mu\text{F}$  tantalum or electrolytic capacitors at the supplies to minimize any transient disturbance and to filter low frequency ripple. Figure 46 illustrates the basic supply bypassing configuration for the AD5122/AD5142.

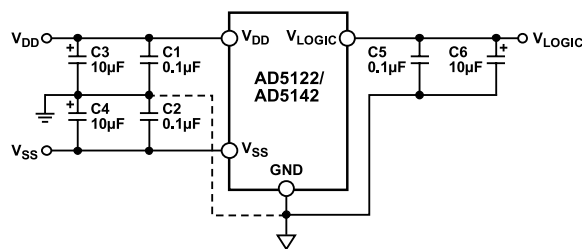


Figure 46. Power Supply Bypassing

## OUTLINE DIMENSIONS

Package Drawing (Option)	Package Type	Package Description
CP-16-22	LFCSP	16-Lead Lead Frame Chip Scale Package
RU-16	TSSOP	16-Lead Thin Shrink Small Outline Package

For the latest package outline information and land patterns (footprints), go to [Package Index](#).

## ORDERING GUIDE

Model <sup>1,2</sup>	Temperature Range	Package Description	Package Option	Branding
AD5122BCPZ10-RL7	-40°C to +125°C	16-Lead LFCSP	CP-16-22	DH8
AD5122BCPZ100-RL7	-40°C to +125°C	16-Lead LFCSP	CP-16-22	DH9
AD5122WBCPZ10-RL7	-40°C to +125°C	16-Lead LFCSP	CP-16-22	DMY
AD5122BRUZ10	-40°C to +125°C	16-Lead TSSOP	RU-16	
AD5122BRUZ100	-40°C to +125°C	16-Lead TSSOP	RU-16	
AD5122BRUZ10-RL7	-40°C to +125°C	16-Lead TSSOP	RU-16	
AD5122WBRUZ10-RL7	-40°C to +125°C	16-Lead TSSOP	RU-16	
AD5122BRUZ100-RL7	-40°C to +125°C	16-Lead TSSOP	RU-16	
AD5142BCPZ10-RL7	-40°C to +125°C	16-Lead LFCSP	CP-16-22	DH5
AD5142BCPZ100-RL7	-40°C to +125°C	16-Lead LFCSP	CP-16-22	DH6
AD5142WBCPZ10-RL7	-40°C to +125°C	16-Lead LFCSP	CP-16-22	DN0
AD5142BRUZ10	-40°C to +125°C	16-Lead TSSOP	RU-16	
AD5142BRUZ100	-40°C to +125°C	16-Lead TSSOP	RU-16	
AD5142BRUZ10-RL7	-40°C to +125°C	16-Lead TSSOP	RU-16	
AD5142WBRUZ10-RL7	-40°C to +125°C	16-Lead TSSOP	RU-16	
AD5142BRUZ100-RL7	-40°C to +125°C	16-Lead TSSOP	RU-16	

<sup>1</sup> Z = RoHS Compliant Part.

<sup>2</sup> W = Qualified for Automotive Applications.

**R<sub>AB</sub> (KΩ), RESOLUTION, AND INTERFACE OPTIONS**

Model <sup>1,2</sup>	R <sub>AB</sub> (kΩ)	Resolution	Interface
AD5122BCPZ10-RL7	10	128	SPI
AD5122BCPZ100-RL7	100	128	SPI
AD5122WBCPZ10-RL7	10	128	SPI
AD5122BRUZ10	10	128	SPI
AD5122BRUZ100	100	128	SPI
AD5122BRUZ10-RL7	10	128	SPI
AD5122WBRUZ10-RL7	10	128	SPI
AD5122BRUZ100-RL7	100	128	SPI
AD5142BCPZ10-RL7	10	256	SPI
AD5142BCPZ100-RL7	100	256	SPI
AD5142WBCPZ10-RL7	10	256	SPI
AD5142BRUZ10	10	256	SPI
AD5142BRUZ100	100	256	SPI
AD5142BRUZ10-RL7	10	256	SPI
AD5142WBRUZ10-RL7	10	256	SPI
AD5142BRUZ100-RL7	100	256	SPI

<sup>1</sup> Z = RoHS Compliant Part.

<sup>2</sup> W = Qualified for Automotive Applications.

**OUTLINE DIMENSIONS****EVALUATION BOARDS**

Model <sup>1, 2</sup>	Description
EVAL-AD5142DBZ	Evaluation Board

<sup>1</sup> Z = RoHS Compliant Part.

<sup>2</sup> The evaluation board is shipped with the 10 kΩ RAB resistor option; however, the board is compatible with all of the available resistor value options.

**AUTOMOTIVE PRODUCTS**

The AD5122W and AD5142W models are available with controlled manufacturing to support the quality and reliability requirements of automotive applications. Note that these automotive models may have specifications that differ from the commercial models; therefore, designers should review the [Specifications](#) section of this data sheet carefully. Only the automotive grade products shown are available for use in automotive applications. Contact your local Analog Devices account representative for specific product ordering information and to obtain the specific Automotive Reliability reports for these models.

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